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Contents

Intelle	Intellectual Property Rights11		
Forew	Foreword11		
Modal	Modal verbs terminology11		
Introd	Introduction1		
1	Scope		
2	References		
2.1	Normative references		
2.2	Informative references		
3	Definitions, symbols, abbreviations and coding conventions		
3.1	Definitions		
3.2	Symbols		
3.3	Abbreviations		
3.4	Coding conventions		
3.5	Applicability		
3.5.1	Applicability of the present document		
3.5.2	Applicability of the individual test cases		
3.5.3	Applicability to terminal equipment		
3.6	Definitions		
3.6.1	Format of table of the table of optional features		
3.6.2	Format of the applicability table		
3.6.3	Status and Notations		
3.7	Table of optional features		
3.8	Applicability table		
4			
	Physical characteristic tests		
4.1	Contact pressure		
4.1.1	Definition and applicability		
4.1.2	Conformance requirement		
4.1.2.1			
4.1.3	Test purpose		
4.1.4	Method of test		
4.1.4.1	Initial conditions		
4.1.4.2			
4.1.5	Acceptance criteria		
4.2	Curvature of the contacting elements		
4.2.1	Definition and applicability		
4.2.2	Conformance requirement		
4.2.2.1			
4.2.3 4.2.4	Test purpose		
4.2.4	Method of test		
4.2.4.2			
4.2.5	Acceptance criteria	20	
5	Electrical characteristic tests		
5.1	Test of the power transition phases		
5.1.1	Phase preceding Terminal power on		
5.1.1.1			
5.1.1.2			
5.1.1.3			
5.1.1.4			
5.1.1.5	• •		
5.1.1.5			
5.1.1.5			
5.1.1.6			
5.1.2	Phase during UICC power on		
	0 r		

5.1.2.1	Phase during UICC power on: 3 V - 5 V	21
5.1.2.1	Definition and applicability	
5.1.2.1.2	Conformance requirement	
5.1.2.1.3	Reference	
5.1.2.1.4	Test purpose	
5.1.2.1.5	Method of test	
5.1.2.1.6	Acceptance criteria	21
5.1.2.2	Phase during UICC power on: 1,8 V - 3 V	22
5.1.2.2.1	Definition and applicability	
5.1.2.2.2	Conformance requirement	
5.1.2.2.3	Reference	
5.1.2.2.4	Test purpose	
5.1.2.2.5	Method of test	
5.1.2.2.6	Acceptance criteria	
5.1.3	Phase during Terminal power off	
5.1.3.1	Phase during Terminal power off: 3 V - 5 V	
5.1.3.1.1 5.1.3.1.2	Definition and applicability	
5.1.3.1.2	Conformance requirement Reference	
5.1.3.1.4	Test purpose	
5.1.3.1.4	Method of test	
5.1.3.1.6	Acceptance criteria	
5.1.3.2	Phase during Terminal power off: 1.8 V - 3 V	
5.1.3.2.1	Definition and applicability	
5.1.3.2.2	Conformance requirement	
5.1.3.2.3	Reference	
5.1.3.2.4	Test purpose	
5.1.3.2.5	Method of test	
5.1.3.2.6	Acceptance criteria	24
5.1.4	Warm reset timing	25
5.1.4.1	Definition and applicability	
5.1.4.2	Conformance requirement	
5.1.4.2.1	Reference	
5.1.4.3	Test purpose	
5.1.4.4	Method of test	
5.1.4.4.1	Initial conditions	
5.1.4.4.2 5.1.4.5	Procedure	
5.1.4.5	Acceptance criteria UICC type recognition and voltage switching	23 26
5.1.5.1	Reaction of 3 V technology Terminals on type recognition of 3 V technology UICCs	20 26
5.1.5.1.1	Definition and applicability	
5.1.5.1.2	Conformance requirement	
5.1.5.1.3	Reference	
5.1.5.1.4	Test purpose	
5.1.5.1.5	Method of test	
5.1.5.1.6	Acceptance criteria	
5.1.5.2	Reaction of 3 V technology Terminals on type recognition of 1,8 V technology UICCs	
5.1.5.2.1	Definition and applicability	
5.1.5.2.2	Conformance requirement	27
5.1.5.2.3	Reference	
5.1.5.2.4	Test purpose	
5.1.5.2.5	Method of test	
5.1.5.2.6	Acceptance criteria	
5.1.5.3	Reaction of 1,8 V technology Terminals on type recognition of 1,8 V technology UICCs	
5.1.5.3.1 5.1.5.3.2	Definition and applicability	
5.1.5.3.2	Conformance requirement Reference	
5.1.5.3.4	Test purpose	
5.1.5.3.5	Method of test	
5.1.5.3.6	Acceptance criteria	
5.1.5.4	Reaction of 1,8 V technology Terminals on type recognition of 3 V technology UICCs	
5.1.5.4.1	Definition and applicability	

5.1.5.4.2	Conformance requirement	28
5.1.5.4.3	Reference	
5.1.5.4.4	Test purpose	
5.1.5.4.5	Method of test	
5.1.5.4.6	Acceptance criteria	
5.1.5.5	Void	
5.1.5.6	Reaction of Terminals receiving no ATR	
5.1.5.6.1	Reaction of Terminals receiving no ATR, 3 V - 5 V	
5.1.5.6.2	Reaction of Terminals receiving no ATR, 1,8 V - 3 V	
5.2	Electrical tests on each Terminal contact	
5.2.1	Nominal test conditions	
5.2.2	Electrical tests on contact C1	
5.2.2.1	Electrical tests on contact C1, Test 1: 3 V - 5 V	
5.2.2.1.1	Definition and applicability	
5.2.2.1.2	Conformance requirement	
5.2.2.1.3	Reference	
5.2.2.1.4	Test purpose	
5.2.2.1.5	Method of test	
5.2.2.1.6	Acceptance criteria	
5.2.2.2	Electrical tests on contact C1, Test 2: 3 V - 5 V	
5.2.2.2.1	Definition and applicability	
5.2.2.2.2	Conformance requirement	
5.2.2.2.3	Reference	
5.2.2.2.4	Test purpose	
5.2.2.2.5	Method of test	
5.2.2.2.6	Acceptance criteria	
5.2.2.3	Electrical tests on contact C1, Test 1: 1,8 V - 3 V	
5.2.2.3.1	Definition and applicability	
5.2.2.3.2	Conformance requirement	
5.2.2.3.3	Reference	
5.2.2.3.4	Test purpose	
5.2.2.3.5	Method of test	
5.2.2.3.6	Acceptance criteria	
5.2.2.4	Electrical tests on contact C1, Test 2: 1,8 V - 3 V	
5.2.2.4.1	Definition and applicability	
5.2.2.4.2	Conformance requirement	
5.2.2.4.3	Reference	
5.2.2.4.4	Test purpose	
5.2.2.4.5	Method of test	
5.2.2.4.6	Acceptance criteria	
5.2.3	Electrical tests on contact C2	
5.2.3.1	Electrical tests on contact C2: 3 V - 5 V	
5.2.3.1.1	Definition and applicability	
5.2.3.1.2	Conformance requirement	
5.2.3.1.3	Reference	
5.2.3.1.4	Test purpose	
5.2.3.1.5	Method of test	
5.2.3.1.6	Acceptance criteria	
5.2.3.2	Electrical tests on contact C2: 1,8 V - 3 V	
5.2.3.2.1	Definition and applicability	
5.2.3.2.2	Conformance requirement	
5.2.3.2.3	Reference	
5.2.3.2.4	Test purpose	
5.2.3.2.5	Method of test	
5.2.3.2.6	Acceptance criteria	
5.2.4	Electrical tests on contact C3.	
5.2.4.1	Electrical tests on contact C3: 3 V - 5 V	
5.2.4.1.1	Definition and applicability	
5.2.4.1.2	Conformance requirement	
5.2.4.1.3	Reference	
5.2.4.1.4	Test purpose	
5.2.4.1.5	Method of test	

5.2.4.1.6	Acceptance criteria	40
5.2.4.2	Electrical tests on contact C3: 1,8 V - 3 V	
5.2.4.2.1	Definition and applicability	
5.2.4.2.2	Conformance requirement	40
5.2.4.2.3	Reference	41
5.2.4.2.4	Test purpose	
5.2.4.2.5	Method of test	
5.2.4.2.6	Acceptance criteria	
5.2.5	Electrical tests on contact C7	
5.2.5.1	Electrical tests on contact C7, Test 1: 3 V - 5 V	
5.2.5.1.1	Definition and applicability	
5.2.5.1.2	Conformance requirement	
5.2.5.1.3	Reference	
5.2.5.1.4	Test purpose	
5.2.5.1.5	Method of test	
5.2.5.1.6	Acceptance criteria	
5.2.5.2	Electrical tests on contact C7, Test 2: 3 V - 5 V	
5.2.5.2.1	Definition and applicability	
5.2.5.2.2	Conformance requirement	
5.2.5.2.3	Reference	
5.2.5.2.4	Test purpose	
5.2.5.2.5	Method of test	
5.2.5.2.6	Acceptance criteria	
5.2.5.3	Electrical tests on contact C7, Test 1: 1,8 V - 3 V	
5.2.5.3.1	Definition and applicability	44
5.2.5.3.2	Conformance requirement	
5.2.5.3.3	Reference	
5.2.5.3.4	Test purpose	
5.2.5.3.5	Method of test	
5.2.5.3.6	Acceptance criteria	
5.2.5.4	Electrical tests on contact C7, Test 2: 1,8 V - 3 V	45
5.2.5.4.1	Definition and applicability	
5.2.5.4.2	Conformance requirement	
5.2.5.4.3	Reference	
5.2.5.4.4	Test purpose	
5.2.5.4.5	Method of test	
5.2.5.4.6	Acceptance criteria	
6 Ini	itial communication tests	
6.1	ATR	
6.1.1	ATR characters	
6.1.1.1	Definition and applicability	
6.1.1.2	Conformance requirement.	
6.1.1.2.1	Reference	
6.1.1.3	Test purpose	
6.1.1.4	Method of test	47
6.1.1.4.1	Initial conditions	
6.1.1.4.2	Procedure	
6.1.1.5	Acceptance criteria	
6.2	Clock stop mode with 1,8 V technology UICC	
6.2.1	Definition and applicability	
6.2.2	Conformance requirement	
6.2.2.1	Reference	
6.2.3	Test purpose	
6.2.4	Method of test	
6.2.4.1	Initial conditions	
6.2.4.2	Procedure	
6.2.5	Acceptance criteria	
6.3	Clock stop mode with 3 V technology UICC	
6.3.1	Definition and applicability	
6.3.2	Conformance requirement	
6.3.2.1	Reference	
0.0.4.1		

6.3.3	Test purpose	53
6.3.4	Method of test	
6.3.4.1	Initial conditions	53
6.3.4.2	Procedure	53
6.3.5	Acceptance criteria	55
6.4	Void	55
6.5	Speed enhancement	55
6.5.1	Definition and applicability	55
6.5.2	Conformance requirement	55
6.5.3	Test purpose	55
6.5.4	Method of test	55
6.5.4.1	Initial conditions	55
6.5.4.2	Procedure	55
6.5.5	Acceptance criteria	56
7 Tr	ansmission protocol tests	57
7.1	Character transmission	
7.1.1	Bit/character duration during the transmission from the Terminal to the UICC	
7.1.1	Definition and applicability	
7.1.1.2	Conformance requirement	
7.1.1.2	Reference	
7.1.1.2.1	Test purpose	
7.1.1.3	1 1	
7.1.1.4	Method of test	
,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	Initial conditions	
7.1.1.4.2	Procedure	
7.1.1.5	Acceptance criteria	
7.1.2	Bit/character duration during the transmission from the UICC to the Terminal	
7.1.2.1	Definition and applicability	
7.1.2.2	Conformance requirement	
7.1.2.2.1	Reference	
7.1.2.3	Test purpose	
7.1.2.4	Method of test	
7.1.2.4.1	Initial conditions	
7.1.2.4.2	Procedure	
7.1.2.5	Acceptance criteria	
7.2	T=0 protocol	
7.2.1	Timing	
7.2.1.1	Definition and applicability	58
7.2.1.2	Conformance requirement	58
7.2.1.2.1	Reference	58
7.2.1.3	Test purpose	58
7.2.1.4	Method of test	59
7.2.1.4.1	Initial conditions	59
7.2.1.4.2	Procedure	59
7.2.1.5	Acceptance criteria	60
7.2.2	Command processing, ACK, NACK, NULL procedure bytes	
7.2.2.1	Definition and applicability	
7.2.2.2	Conformance requirement	60
7.2.2.2.1	Reference	
7.2.2.3	Test purpose	60
7.2.2.4	Method of test	
7.2.2.4.1	Initial conditions	
7.2.2.4.2	Procedure	
7.2.2.5	Acceptance criteria	
7.2.3	Case 2 command, use of procedure bytes '61xx' and '6Cxx'	
7.2.3.1	Definition and applicability	
7.2.3.2	Conformance requirement	
7.2.3.2.1	Reference	
7.2.3.2.1	Test purpose	
7.2.3.3	Method of test	
7.2.3.4	Initial conditions	
7.2.3.4.2	Procedure	

7.2.3.5	Acceptance criteria	61
7.2.4	Case 4 command, use of procedure bytes '61xx'	
7.2.4.1	Definition and applicability	
7.2.4.2	Conformance requirement	
7.2.4.2.1	Reference	
7.2.4.3	Test purpose	
7.2.4.4	Method of test	
7.2.4.4.1	Initial conditions	
7.2.4.4.2	Procedure	
7.2.4.5	Acceptance criteria	
7.2.5	Command processing, warning and error status bytes	
7.2.5.1	Definition and applicability	
7.2.5.2	Conformance requirement	
7.2.5.2.1	•	
	Reference	
7.2.5.3	Test purpose	
7.2.5.4	Method of test	
7.2.5.4.1	Initial conditions	
7.2.5.4.2	Procedure	
7.2.5.5	Acceptance criteria	
7.2.6	Error correction	
7.2.6.1	Definition and applicability	
7.2.6.2	Conformance requirement	
7.2.6.2.1	Reference	
7.2.6.3	Test purpose	
7.2.6.4	Method of test	
7.2.6.4.1	Initial conditions	
7.2.6.4.2	Procedure	
7.2.6.5	Acceptance criteria	64
7.2.7	Error detection	64
7.2.7.1	Definition and applicability	64
7.2.7.2	Conformance requirement	64
7.2.7.2.1	Reference	64
7.2.7.3	Test purpose	
7.2.7.4	Method of test	64
7.2.7.4.1	Initial conditions	
7.2.7.4.2	Procedure	64
7.2.7.5	Acceptance criteria	
7.3	T=1 protocol	64
7.3.1	Character Waiting Time	
7.3.1.1	Definition and applicability	
7.3.1.2	Conformance requirement	
7.3.1.2.1	Reference	
7.3.1.3	Test purpose	
7.3.1.4	Method of test	
7.3.1.4.1	Initial conditions	
7.3.1.4.2	Procedure	
7.3.1.5	Acceptance criteria	
7.3.2	Block Timing	
7.3.2.1	Definition and applicability	
7.3.2.1		
	Conformance requirement	
7.3.2.2.1	Reference	
7.3.2.3	Test purpose	
7.3.2.4	Method of test	
7.3.2.4.1	Initial conditions	
7.3.2.4.2	Procedure	
7.3.2.5	Acceptance criteria	
7.3.3	Block Waiting Time extension	
7.3.3.1	Definition and applicability	
7.3.3.2	Conformance requirement	
7.3.3.2.1	Reference	
7.3.3.3	Test purpose	
7.3.3.4	Method of test	

ETSI TS 102 230 V10.2.0 (2015-03)

7.3.4.2 Procedure. 68 7.3.5.5 Acceptance criteria. 69 7.3.4 Chaimiag. Respect of IFSC by Terminal. 69 7.3.4.1 Definition and applicability. 69 7.3.4.2 Conformance requirement. 69 7.3.4.2 Reference. 69 7.3.4.3 Test purpose. 69 7.3.4.4 Initial conditions. 69 7.3.4.4.1 Initial conditions. 69 7.3.4.4.2 Procedure. 69 7.3.4.4.3 Catoprance criteria. 71 7.3.5.4 Method of test. 71 7.3.5.5 Conformance requirement. 71 7.3.5.1 Definition and applicability. 71 7.3.5.2 Conformance requirement. 71 7.3.5.4 Method of test. 71 7.3.5.4 Method of test. 71 7.3.5.4 Procedure. 72 7.3.5.4 Method of test. 72 7.3.5.1 Definition and applicability. 72 7.3.5.2 Conformance requirement. 72 7.3	7.3.3.4.1	Initial conditions	68
7.3.4.1 Definition and applicability	7.3.3.4.2		
7.3.4.1 Definition and applicability.	7.3.3.5	Acceptance criteria	69
7.3.4.2. Conformance requirement	7.3.4		
7.3.4.2.1 Reference. 69 7.3.4.3 Test purpose. 69 7.3.4.4 Method of test 69 7.3.4.4.1 Initial conditions. 69 7.3.4.4.2 Procedure. 69 7.3.4.4.3 Acceptance criteria. 71 7.3.5 Choining -IFSD management 71 7.3.5.1 Definition and applicability. 71 7.3.5.2 Conformance requirement 71 7.3.5.3 Test purpose 71 7.3.5.4 Method of test 71 7.3.5.4 Initial conditions. 71 7.3.5.4 Definition and applicability. 72 7.3.6.1 Definition and applicability. 72 7.3.6.2 Conformance requirement 72 7.3.6.3 Test purpose 72 7.3.6.4 Method of test 72 7.3.6.4 Procedure 72 7.3.6.4 Procedure 72 7.3.6.4 Procedure 72 7.3.7.1 HeBock error detection 72 7.3.7.2 Conformance requirement <td>7.3.4.1</td> <td>Definition and applicability</td> <td>69</td>	7.3.4.1	Definition and applicability	69
7.3.4.3 Test purpose 69 7.3.4.4 Initial conditions 69 7.3.4.4.1 Initial conditions 69 7.3.4.2 Procedure 69 7.3.4.3 Acceptance criteria 71 7.3.5 Chaiming - IFSD management 71 7.3.5.1 Definition and applicability 71 7.3.5.2 Conformance requirement 71 7.3.5.3 Test purpose 71 7.3.5.4 Method of test 71 7.3.5.4 Initial conditions 71 7.3.5.4 Deformere requirement 71 7.3.5.4 Deformere requirement 71 7.3.5.4 Deformere requirement 72 7.3.6.1 Deformere requirement 72 7.3.6.2 Conformance requirement 72 7.3.6.3 Test purpose 72 7.3.6.4 Deformere requirement 72 7.3.6.1 Deformere requirement 72 7.3.6.2 Reference 72 7.3.6.3 Test purpose 72 7.3.6.4 Deformiton and ap	7.3.4.2	Conformance requirement	69
7.3.4.4. Method of test 69 7.3.4.4.1 Inrial conditions 69 7.3.4.4.2 Procedure 69 7.3.4.4.3 Acceptance criteria 71 7.3.5 Chaining - IPSD management 71 7.3.5.1 Definition and applicability 71 7.3.5.2 Conformance requirement 71 7.3.5.3 Test purpose 71 7.3.5.4 Method of test 71 7.3.5.4 Initial conditions 71 7.3.5.4 Acceptance criteria 71 7.3.6.1 Definition and applicability 72 7.3.6.1 Definition and applicability 72 7.3.6.2 Conformance requirement 72 7.3.6.3 Test purpose 72 7.3.6.4 Method of test 72 7.3.6.4 Method of test 72 7.3.7.1 FBlock error detection 72 7.3.7.2 Conformance requirement 72 7.3.7.1 FBlock error detection 72 7.3.7.2 Conformance requirement 73 7.3.7.	7.3.4.2.1		
7.3.4.4.1 Initial conditions	7.3.4.3	Test purpose	69
73.44.2 Procedure 69 73.45 Acceptance oriteria 71 73.5 Chaining - IFSD management 71 73.5.1 Definition and applicability 71 73.5.2 Conformance requirement 71 73.5.3 Test purpose 71 73.5.4 Method of test 71 73.5.4 Initial conditions 71 73.5.4 Procedure 71 73.5.4 Initial conditions 71 73.5.4 Procedure 71 73.5.4 Definition and applicability 72 73.6.1 Definition and applicability 72 73.6.2 Conformance requirement 72 73.6.3 Test purpose 72 73.6.4 Method of est 72 73.6.4 Method of est 72 73.7 Testor prose 72 73.7.1 Definition and applicability 72 73.7.2 Conformance requirement 72 73.7.1 Definition and applicability 73 73.7.1 Definition and applicability<	7.3.4.4	Method of test	69
7.3.4.5 Acceptance criteria 71 7.3.5 Chaining : IFSD management 71 7.3.5.1 Definition and applicability. 71 7.3.5.2 Conformance requirement. 71 7.3.5.2 Conformance requirement. 71 7.3.5.4 Reference 71 7.3.5.4 Method of test. 71 7.3.5.4 Method of test. 71 7.3.5.4 Procedure 71 7.3.5.4 Procedure 71 7.3.5.4 Procedure 71 7.3.6.1 Block error correction 72 7.3.6.1 Block error correction 72 7.3.6.2 Conformance requirement 72 7.3.6.3 Test purpose 72 7.3.6.4 Initial conditions 72 7.3.6.4.1 Initial conditions 72 7.3.6.2 Procedure 72 7.3.6.3 Acceptance criteria 72 7.3.6.4 Initial conditions 72 7.3.6.5 Acceptance criteria 72 7.3.7.1 Bofenerori detection	7.3.4.4.1	Initial conditions	69
7.35 Chaimig - IFSD management 71 7.35.1 Definition and applicability 71 7.35.2 Conformance requirement 71 7.35.3 Test purpose 71 7.35.4 Method of test 71 7.35.4.1 Initial conditions 71 7.35.4 Hendo of test 71 7.35.4 Procedure 71 7.35.5 Acceptance criteria 71 7.36 I-Block error correction 72 7.36.1 Definition and applicability 72 7.36.2 Conformance requirement 72 7.36.3 Test purpose 72 7.36.4 Method of test 72 7.36.4 Initial conditions 72 7.36.4 Initial conditions 72 7.36.4 Initial conditions 72 7.37.1 Definition and applicability 72 7.37.2 Conformance requirement 73 7.37.3 Deceptance criteria 73 7.37.4 Definition and applicability 73 7.37.5 Accept	7.3.4.4.2	Procedure	69
7.35.1 Definition and applicability. 71 7.35.2 Conformance requirement. 71 7.35.3 Reference. 71 7.35.4 Method of test. 71 7.35.5.4 Initial conditions. 71 7.35.5.4 Method of test. 71 7.35.5.5 Acceptance criteria. 71 7.35.6 I-Block error correction 72 7.3.6.1 Definition and applicability. 72 7.3.6.2 Conformance requirement. 72 7.3.6.3 Test purpose. 72 7.3.6.4 Initial conditions. 72 7.3.6.4 Initial conditions. 72 7.3.6.4 Procedure 72 7.3.6.4 Procedure 72 7.3.6.4 Procedure 72 7.3.6.4 Procedure 72 7.3.6.5 Acceptance criteria 72 7.3.7 I-Block error detection 72 7.3.7.1 Definition and applicability. 72 7.3.7.2 Conformance requirement. 73 7.3.7.4 Method of	7.3.4.5	Acceptance criteria	71
7.3.5.2. Conformance requirement. 71 7.3.5.3. Test purpose 71 7.3.5.4. Method of test 71 7.3.5.4. Initial conditions. 71 7.3.5.4. Initial conditions. 71 7.3.5.4. Procedure 71 7.3.5.4. Procedure criteria. 71 7.3.6. Conformance requirement. 72 7.3.6.1. Definition and applicability. 72 7.3.6.2. Reference 72 7.3.6.3. Test purpose 72 7.3.6.4. Method of test 72 7.3.6.4. Initial conditions. 72 7.3.6.4. Procedure 72 7.3.6.4. Procedure 72 7.3.6.4. Procedure 72 7.3.6.4. Procedure 72 7.3.6.5. Acceptance criteria. 72 7.3.7.1. Definition and applicability. 72 7.3.7.2. Conformance requirement. 73 7.3.7.3. Test purpose 73 7.3.7.4. Method of test 73	7.3.5		
7.3.5.2.1 Reference 71 7.3.5.3 Test purpose 71 7.3.5.4 Method of test 71 7.3.5.4 Initial conditions 71 7.3.5.4 Procedure 71 7.3.5.4 Procedure 71 7.3.5.4 Procedure 71 7.3.5.4 Procedure 71 7.3.5.5 Acceptance criteria 71 7.3.6 I-Block error correction 72 7.3.6.1 Definition and applicability 72 7.3.6.2 Conformance requirement. 72 7.3.6.4 Initial conditions 72 7.3.6.5 Acceptance criteria 72 7.3.6.4 Procedure 72 7.3.6.5 Acceptance criteria 72 7.3.6.6 Acceptance criteria 72 7.3.7.1 Posterroc detection 72 7.3.7.2 Conformance requirement 73 7.3.7.3 Test purpose 73 7.3.7.4 Method of test 73 7.3.7.5 Acceptance criteria 73 <tr< td=""><td>7.3.5.1</td><td></td><td></td></tr<>	7.3.5.1		
7.3.5.3 Test purpose 71 7.3.5.4.1 Initial conditions 71 7.3.5.4.2 Procedure 71 7.3.5.4.2 Procedure criteria 71 7.3.5.4 Definition and applicability 72 7.3.6.1 Definition and applicability 72 7.3.6.1 Definition and applicability 72 7.3.6.2 Reference 72 7.3.6.3 Test purpose 72 7.3.6.4 Method of test 72 7.3.6.4 Procedure 72 7.3.6.5 Acceptance criteria 72 7.3.7 Test purpose 73 7.3.7.1 Definition and applicability 72 7.3.7.2 Conformance requirement 73 7.3.7.3 Test purpose 73 7.3.7.4 Initial conditions 73 7.3.7.5 Acceptance criteria 73 <t< td=""><td>7.3.5.2</td><td>Conformance requirement</td><td>71</td></t<>	7.3.5.2	Conformance requirement	71
7.3.5.4 Method of test 71 7.3.5.4.1 Initial conditions 71 7.3.5.4.2 Procedure 71 7.3.5.4 Procedure 71 7.3.5.4 Procedure 71 7.3.6 1.Block error correction 72 7.3.6.1 Definition and applicability 72 7.3.6.2 Conformance requirement 72 7.3.6.3 Test purpose 72 7.3.6.4 Initial conditions 72 7.3.6.4 Initial conditions 72 7.3.6.4 Procedure 72 7.3.7 1-Block error detection 72 7.3.7.1 Definition and applicability. 72 7.3.7.2 Conformance requirement 73 7.3.7.3 Test purpose 73 7.3.7.4 Method of test 73 7.3.7.5 Acceptance criteria. 73	7.3.5.2.1		
7.3.5.4.1 Initial conditions. 71 7.3.5.4.2 Procedure. 71 7.3.5.5 Acceptance criteria. 71 7.3.6.1 Definition and applicability. 72 7.3.6.2 Conformance requirement. 72 7.3.6.3 Test purpose 72 7.3.6.4 Method of test 72 7.3.6.4 Initial conditions. 72 7.3.6.4.1 Initial conditions. 72 7.3.6.4 Procedure. 72 7.3.6.4 Procedure. 72 7.3.6.4 Procedure. 72 7.3.6.4 Procedure. 72 7.3.6.5 Acceptance criteria. 72 7.3.6.6 Acceptance criteria. 72 7.3.7.1 Definition and applicability. 72 7.3.7.2 Conformance requirement. 73 7.3.7.3 Test purpose. 73 7.3.7.4 Method of test. 73 7.3.7.5 Acceptance criteria. 73 7.3.7.4 Definition and applicability. 73 7.3.7.5 Acceptance cri	7.3.5.3		
7.3.5.4.2 Procedure			
7.3.5.5 Acceptance criteria. 71 7.3.6.1 I-Block error correction 72 7.3.6.2 Conformance requirement. 72 7.3.6.3 Test purpose. 72 7.3.6.4 Method of test. 72 7.3.6.4 Initial conditions 72 7.3.6.4 Initial conditions 72 7.3.6.4 Procedure. 72 7.3.6.4 Initial conditions 72 7.3.6.4 Procedure. 72 7.3.6.1 Ellock error detection 72 7.3.7 I-Block error detection 72 7.3.7.1 Definition and applicability. 72 7.3.7.2 Conformance requirement. 73 7.3.7.3 Test purpose 73 7.3.7.4 Procedure 73 7.3.7.5 Acceptance criteria 73 7.3.8 R-Block error handling in non-chaining mode			
7.3.6. I-Block error correction 72 7.3.6.1 Definition and applicability. 72 7.3.6.2 Conformance requirement. 72 7.3.6.3 Test purpose. 72 7.3.6.4 Method of test. 72 7.3.6.4 Initial conditions. 72 7.3.6.4 Initial conditions. 72 7.3.6.4.1 Initial conditions. 72 7.3.6.4 Procedure. 72 7.3.6.5 Acceptance criteria 72 7.3.6.7 I-Block error detection. 72 7.3.7.1 Definition and applicability. 72 7.3.7.2 Conformance requirement. 73 7.3.7.3 Test purpose. 73 7.3.7.4 Method of test. 73 7.3.7.4 Initial conditions 73 7.3.7.4 Procedure 73 7.3.7.8 R-Block error handling in non-chaining mode 73 7.3.8.1 Definition and applicability. 74 7.3.8.2 Reference 74 7.3.8.3 Test purpose. 74 7			
7.3.6.1 Definition and applicability. 72 7.3.6.2 Conformance requirement. 72 7.3.6.3 Test purpose. 72 7.3.6.4 Method of test. 72 7.3.6.5 Test purpose. 72 7.3.6.4 Initial conditions. 72 7.3.6.4 Initial conditions. 72 7.3.6.4 Procedure 72 7.3.6.5 Acceptance criteria. 72 7.3.6.5 Acceptance criteria. 72 7.3.7.1 Definition and applicability. 72 7.3.7.2 Conformance requirement. 73 7.3.7.3 Test purpose. 73 7.3.7.4 Initial conditions. 73 7.3.7.4 Procedure. 73 7.3.7.5 Acceptance criteria. 73 7.3.8 R-Block error handling in non-chaining mode. 73 7.3.8.1 Definition and applicability. 73 7.3.8.2 Conformance requirement. 74 7.3.8.3 Test purpose. 74 7.3.8.4 Method of test. 74			
7.3.6.2 Conformance requirement. 72 7.3.6.3 Reference 72 7.3.6.4 Method of test 72 7.3.6.4 Method of test 72 7.3.6.4 Method of test 72 7.3.6.4 Procedure 72 7.3.6.4.2 Procedure 72 7.3.6.5 Acceptance criteria 72 7.3.7 I-Block error detection 72 7.3.7.1 Definition and applicability 72 7.3.7.2 Conformance requirement. 73 7.3.7.3 Test purpose 73 7.3.7.4 Method of test 73 7.3.7.4 Initial conditions 73 7.3.7.5 Acceptance criteria 73 7.3.7.4 Procedure 73 7.3.7.5 Acceptance criteria 73 7.3.8 R-Block error handling in non-chaining mode 73 7.3.8.1 Definition and applicability 73 7.3.8.2 Conformance requirement 74 7.3.8.3 Test purpose 74 7.3.8.4 Method of test			
7.3.6.2.1 Reference 72 7.3.6.3 Test purpose 72 7.3.6.4 Initial conditions 72 7.3.6.4.1 Initial conditions 72 7.3.6.4.1 Initial conditions 72 7.3.6.5 Acceptance criteria 72 7.3.6.7 I-Block error detection 72 7.3.7 I-Block error detection 72 7.3.7.1 Definition and applicability 72 7.3.7.2 Conformance requirement 73 7.3.7.3 Test purpose 73 7.3.7.4 Method of test 73 7.3.7.5 Acceptance criteria 73 7.3.7.4.1 Initial conditions 73 7.3.7.2 Procedure 73 7.3.7.4 Procedure 73 7.3.7.5 Acceptance criteria 73 7.3.8 R-Block error handling in non-chaining mode 73 7.3.8.1 Definition and applicability 73 7.3.8.2 Reference 74 7.3.8.3 Test purpose 74 7.3.8.4.1 Initial			
73.6.3 Test purpose 72 7.3.6.4 Method of test 72 7.3.6.4.1 Initial conditions 72 7.3.6.4.2 Procedure 72 7.3.6.4.3 Acceptance criteria 72 7.3.6.4.4 Procedure 72 7.3.6.4.1 Initial conditions 72 7.3.6.4.2 Procedure 72 7.3.6.4.3 Acceptance criteria 72 7.3.7 I-Block error detection 72 7.3.7.1 Definition and applicability 72 7.3.7.2 Conformance requirement 73 7.3.7.3 Test purpose 73 7.3.7.4 Method of test 73 7.3.7.4.1 Initial conditions 73 7.3.7.5 Acceptance criteria 73 7.3.8 R-Block error handling in non-chaining mode 73 7.3.8.1 Definition and applicability 73 7.3.8.2 Conformance requirement 74 7.3.8.3 Test purpose 74 7.3.8.4 Method of test 74 7.3.8.5 A			
7.3.6.4 Method of test 72 7.3.6.4.1 Initial conditions 72 7.3.6.4.2 Procedure 72 7.3.6.5 Acceptance criteria 72 7.3.6.5 Acceptance criteria 72 7.3.7 I-Block error detection 72 7.3.7.1 Definition and applicability 72 7.3.7.2 Conformance requirement 73 7.3.7.3 Test purpose 73 7.3.7.4.1 Initial conditions 73 7.3.7.4.1 Initial conditions 73 7.3.7.4.1 Initial conditions 73 7.3.7.5 Acceptance criteria 73 7.3.7.4 Procedure 73 7.3.7.5 Acceptance criteria 73 7.3.8 R-Block error handling in non-chaining mode 73 7.3.8.1 Definition and applicability 73 7.3.8.2 Conformance requirement 74 7.3.8.3 Test purpose 74 7.3.8.4.1 Initial conditions 74 7.3.8.2 Conformance requirement 74 <t< td=""><td></td><td></td><td></td></t<>			
73.6.4.1 Initial conditions 72 73.6.5 Acceptance criteria 72 73.7 I-Block error detection 72 73.7.1 Definition and applicability 72 73.7.2 Conformance requirement 73 73.7.3 Test purpose 73 73.7.4 Method of test 73 73.7.4 Definition and applicability 73 73.7.4 Method of test 73 73.7.5 Acceptance criteria 73 73.8.8 R-Block error handling in non-chaining mode 73 73.8.1 Definition and applicability 73 73.8.2 Conformance requirement 74 73.8.3 Test purpose 74 73.8.4 Method of test 73 73.8.1 Definition and applicability 73 73.8.2 Conformance requirement 74 73.8.3 Test purpose 74 73.8.4 Method of test 74 73.8.5 Acceptance criteria 74 73.8.4 Method of test 74 73.8.5			
73.64.2 Procedure			
7.3.6.5 Acceptance criteria 72 7.3.7 I-Block error detection 72 7.3.7.1 Definition and applicability 72 7.3.7.2 Conformance requirement 73 7.3.7.3 Test purpose 73 7.3.7.4 Method of test 73 7.3.7.4 Method of test 73 7.3.7.4 Procedure 73 7.3.7.4 Procedure 73 7.3.7.5 Acceptance criteria 73 7.3.7.4 Procedure 73 7.3.8 R-Block error handling in non-chaining mode 73 7.3.8.1 Definition and applicability 73 7.3.8.2 Conformance requirement 74 7.3.8.3 Test purpose 74 7.3.8.4 Method of test 74 7.3.8.5 Acceptance criteria 74 7.3.9 R-Block error handling in chaining mode 74 7.3.8.4 Method of test 74 7.3.8.5 Acceptance criteria 74 7.3.9 R-Block error handling in chaining mode 75 <t< td=""><td></td><td></td><td></td></t<>			
7.3.7. I-Block error detection 72 7.3.7.1 Definition and applicability 72 7.3.7.2 Conformance requirement 73 7.3.7.2.1 Reference 73 7.3.7.3 Test purpose 73 7.3.7.4 Method of test 73 7.3.7.4 Method of test 73 7.3.7.4 Initial conditions 73 7.3.7.4 Procedure 73 7.3.7.5 Acceptance criteria 73 7.3.8 R-Block error handling in non-chaining mode 73 7.3.8.1 Definition and applicability 73 7.3.8.2 Conformance requirement 74 7.3.8.3 Test purpose 74 7.3.8.4 Method of test 74 7.3.8.4 Procedure 74 7.3.8.4 Procedure 74 7.3.8.5 Acceptance criteria 74 7.3.8.4 Procedure 74 7.3.8.5 Acceptance criteria 74 7.3.9 R-Block eror handling in chaining mode 75 7.3.9.1 Definit			
7.3.7.1 Definition and applicability			
7.3.7.2 Conformance requirement			
7.3.7.2.1 Reference .73 7.3.7.3 Test purpose .73 7.3.7.4 Method of test .73 7.3.7.4.1 Initial conditions .73 7.3.7.4.2 Procedure .73 7.3.7.4.3 Reference criteria .73 7.3.7.4.2 Procedure .73 7.3.7.5 Acceptance criteria .73 7.3.8.1 Definition and applicability .73 7.3.8.2 Conformance requirement .74 7.3.8.3 Test purpose .74 7.3.8.4 Method of test .74 7.3.8.4.1 Initial conditions .74 7.3.8.4.2 Procedure .74 7.3.8.4.2 Procedure .74 7.3.8.4.2 Procedure .74 7.3.9.1 Definition and applicability .74 7.3.9.2 Conformance requirement .74 7.3.9.3 Test purpose .75 7.3.9.4 Initial conditions .74 7.3.9.2 Conformance requirement .75 7.3.9.3 Test purpose			
7.3.7.3 Test purpose 73 7.3.7.4 Method of test 73 7.3.7.4.1 Initial conditions 73 7.3.7.4.1 Initial conditions 73 7.3.7.4.2 Procedure 73 7.3.7.5 Acceptance criteria 73 7.3.8 R-Block error handling in non-chaining mode 73 7.3.8.1 Definition and applicability 73 7.3.8.2 Conformance requirement 74 7.3.8.3 Test purpose 74 7.3.8.4 Method of test 74 7.3.8.4 Method of test 74 7.3.8.4 Method of test 74 7.3.8.4.1 Initial conditions 74 7.3.8.4.2 Procedure 74 7.3.9 R-Block error handling in chaining mode 74 7.3.9.1 Definition and applicability 74 7.3.9.2 Conformance requirement 75 7.3.9.3 Test purpose 75 7.3.9.4 Method of test 75 7.3.9.4 Method of test 75 7.3.9.4			
7.3.7.4 Method of test			
7.3.7.4.1 Initial conditions 73 7.3.7.4.2 Procedure 73 7.3.7.5 Acceptance criteria 73 7.3.8 R-Block error handling in non-chaining mode 73 7.3.8.1 Definition and applicability 73 7.3.8.2 Conformance requirement 74 7.3.8.3 Test purpose 74 7.3.8.4 Method of test 74 7.3.8.4 Initial conditions 74 7.3.8.4 Initial conditions 74 7.3.8.4 Procedure 74 7.3.8.5 Acceptance criteria 74 7.3.8.5 Acceptance criteria 74 7.3.9 R-Block error handling in chaining mode 74 7.3.9.1 Definition and applicability. 74 7.3.9.2 Conformance requirement 75 7.3.9.3 Test purpose 75 7.3.9.4 Method of test 75 7.3.9.4 Method of test 75 7.3.9.4 Procedure 75 7.3.9.4 Procedure 75 7.3.9.5 <t< td=""><td></td><td></td><td></td></t<>			
7.3.7.4.2 Procedure			
7.3.7.5 Acceptance criteria 73 7.3.8 R-Block error handling in non-chaining mode 73 7.3.8.1 Definition and applicability 73 7.3.8.2 Conformance requirement 74 7.3.8.2.1 Reference 74 7.3.8.3 Test purpose 74 7.3.8.4 Method of test 74 7.3.8.4 Method of test 74 7.3.8.4 Initial conditions 74 7.3.8.4 Procedure 74 7.3.8.5 Acceptance criteria 74 7.3.9 R-Block error handling in chaining mode 74 7.3.9.1 Definition and applicability 74 7.3.9.2 Conformance requirement 75 7.3.9.3 Test purpose 75 7.3.9.4 Method of test 75 7.3.9.5 Acceptance criteria 75 7.3.9.4 Procedure 75 7.3.9.5 Acce			
7.3.8 R-Block error handling in non-chaining mode 73 7.3.8.1 Definition and applicability			
7.3.8.1 Definition and applicability		F	
7.3.8.2 Conformance requirement			
7.3.8.2.1 Reference 74 7.3.8.3 Test purpose 74 7.3.8.4 Method of test 74 7.3.8.4 Method of test 74 7.3.8.4.1 Initial conditions 74 7.3.8.4.2 Procedure 74 7.3.8.5 Acceptance criteria 74 7.3.9 R-Block error handling in chaining mode 74 7.3.9.1 Definition and applicability. 74 7.3.9.2 Conformance requirement 75 7.3.9.3 Test purpose 75 7.3.9.4 Method of test 75 7.3.9.5 Acceptance criteria 75 7.3.9.4 Method of test 75 7.3.9.5 Acceptance criteria 75 7.3.9.5 Acceptance criteria 75 7.3.10 Successive errors in both directions 75 7.3.10.1 Definition and applicability 75 7.3.10.2 Conformance requirement 75 7.3.10.2 Conformance requirement 75 7.3.10.2 Conformance requirement 76	7.3.8.2		
7.3.8.4 Method of test			
7.3.8.4 Method of test	7.3.8.3	Test purpose	74
7.3.8.4.2 Procedure	7.3.8.4	* *	
7.3.8.5Acceptance criteria.747.3.9R-Block error handling in chaining mode747.3.9.1Definition and applicability747.3.9.2Conformance requirement757.3.9.2.1Reference757.3.9.3Test purpose.757.3.9.4Method of test.757.3.9.4.1Initial conditions.757.3.9.5Acceptance criteria.757.3.9.5Acceptance criteria.757.3.10Successive errors in both directions.757.3.10.1Definition and applicability757.3.10.2Conformance requirement767.3.10.2.1Reference76	7.3.8.4.1	Initial conditions	74
7.3.9R-Block error handling in chaining mode.747.3.9.1Definition and applicability.747.3.9.2Conformance requirement.757.3.9.2.1Reference.757.3.9.3Test purpose.757.3.9.4Method of test757.3.9.4.1Initial conditions.757.3.9.5Acceptance criteria.757.3.10Successive errors in both directions.757.3.10.1Definition and applicability.757.3.10.2Conformance requirement.767.3.10.2.1Reference.76	7.3.8.4.2	Procedure	74
7.3.9.1Definition and applicability	7.3.8.5	Acceptance criteria	74
7.3.9.2 Conformance requirement. .75 7.3.9.2.1 Reference. .75 7.3.9.3 Test purpose. .75 7.3.9.4 Method of test	7.3.9	R-Block error handling in chaining mode	74
7.3.9.2.1 Reference. .75 7.3.9.3 Test purpose. .75 7.3.9.4 Method of test .75 7.3.9.4.1 Initial conditions. .75 7.3.9.4.2 Procedure. .75 7.3.9.5 Acceptance criteria. .75 7.3.10 Successive errors in both directions. .75 7.3.10.1 Definition and applicability. .75 7.3.10.2 Conformance requirement. .76 7.3.10.2.1 Reference. .76	7.3.9.1	Definition and applicability	74
7.3.9.3 Test purpose .75 7.3.9.4 Method of test .75 7.3.9.4.1 Initial conditions .75 7.3.9.4.2 Procedure .75 7.3.9.5 Acceptance criteria .75 7.3.10 Successive errors in both directions .75 7.3.10.1 Definition and applicability .75 7.3.10.2 Conformance requirement .76 7.3.10.2.1 Reference .76	7.3.9.2	Conformance requirement	75
7.3.9.4Method of test.757.3.9.4.1Initial conditions.757.3.9.4.2Procedure.757.3.9.5Acceptance criteria.757.3.10Successive errors in both directions.757.3.10.1Definition and applicability.757.3.10.2Conformance requirement.767.3.10.2.1Reference.76	7.3.9.2.1	Reference	75
7.3.9.4.1Initial conditions757.3.9.4.2Procedure757.3.9.5Acceptance criteria757.3.10Successive errors in both directions757.3.10.1Definition and applicability757.3.10.2Conformance requirement767.3.10.2.1Reference76		Test purpose	75
7.3.9.4.2Procedure			
7.3.9.5Acceptance criteria.757.3.10Successive errors in both directions.757.3.10.1Definition and applicability.757.3.10.2Conformance requirement.767.3.10.2.1Reference.76			
7.3.10Successive errors in both directions			
7.3.10.1Definition and applicability		•	
7.3.10.2Conformance requirement			
7.3.10.2.1 Reference			
7.5.10.5 Test purpose			
	1.3.10.3	i est purpose	/6

7.3.10.4 Method of test
7.3.10.4.1 Initial conditions
7.3.10.4.2 Procedure
7.3.10.5 Acceptance criteria
7.3.11 Chaining - Abortion
7.3.11.1 Definition and applicability
7.3.11.2 Conformance requirement
7.3.11.2.1 Reference
7.3.11.3 Test purpose
7.3.11.4 Method of test
7.3.11.4.1 Initial conditions
7.3.11.4.2 Procedure
7.3.11.5Acceptance criteria
1 5
7.3.12.1Definition and applicability
7.3.12.2.1 Reference
7.3.12.3 Test purpose
7.3.12.4 Method of test
7.3.12.4.1 Initial conditions
7.3.12.4.2 Procedure
7.3.12.5 Acceptance criteria
7.3.13 UICC is unresponsive
7.3.13.1 Definition and applicability
7.3.13.2 Conformance requirement
7.3.13.2.1 Reference
7.3.13.3 Test purpose
7.3.13.4 Method of test80
7.3.13.4.1 Initial conditions
7.3.13.4.2 Procedure
7.3.13.5 Acceptance criteria
8 Application dependent procedures
8.1 UICC presence detection
8.1.1 Definition and applicability
8.1.2 Conformance requirement
8.1.2.1 Reference
8.1.3 Test purpose
8.1.4 Method of test
8.1.4.1 Initial conditions
8.1.4.2 Procedure
8.1.5 Acceptance criteria
Annex A (normative): UICC simulator functional requirement
A.1 General
A.2 Contacts C1, C3, C7
A.2.1 Default measurement/setting uncertainties
A.2.2 Contact C1
A.2.3 Contact C7
A.2.4 Contact C3
A.3 Definition of timing
Annex B (informative): Change history
History

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Foreword

This Technical Specification (TS) has been produced by ETSI Technical Committee Smart Card Platform (SCP).

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Modal verbs terminology

In the present document "shall", "shall not", "should", "should not", "may", "need not", "will", "will not", "can" and "cannot" are to be interpreted as described in clause 3.2 of the ETSI Drafting Rules (Verbal forms for the expression of provisions).

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Introduction

The present document defines the interface tests for the Terminal/UICC interface.

The aim of the present document is to ensure interoperability between an UICC and a Terminal independently of the respective manufacturer, card issuer or operator.

Application specific tests for applications residing on an UICC are specified in ETSI TS 131 121 [4].

1 Scope

The present document specifies the interface test for the Terminal/UICC.

The present document specifies the tests of:

- physical characteristics of the UICC;
- the electrical interface between the UICC and the Terminal;
- the initial communication establishment and the transport protocols;
- the application independent procedures.

2 References

2.1 Normative references

References are either specific (identified by date of publication and/or edition number or version number) or non-specific. For specific references, only the cited version applies. For non-specific references, the latest version of the reference document (including any amendments) applies.

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NOTE: While any hyperlinks included in this clause were valid at the time of publication, ETSI cannot guarantee their long term validity.

The following referenced documents are necessary for the application of the present document.

- [1] ETSI TS 102 221: "Smart Cards; UICC-Terminal interface; Physical and logical characteristics".
- [2] ISO/IEC 7816-3: "Identification cards Integrated circuit cards Part 3: Cards with contacts -Electrical interface and transmission protocols".
- [3] ETSI TS 121 111: "Universal Mobile Telecommunications System (UMTS); LTE; USIM and IC card requirements (3GPP TS 21.111)".
- [4] ETSI TS 131 121: "Universal Mobile Telecommunications System (UMTS); LTE; UICC-terminal interface; Universal Subscriber Identity Module (USIM) application test specification (3GPP TS 31.121)".
- [5] ISO/IEC 9646-7: "Information technology Open Systems Interconnection Conformance testing methodology and framework Part 7: Implementation Conformance Statements".

2.2 Informative references

References are either specific (identified by date of publication and/or edition number or version number) or non-specific. For specific references, only the cited version applies. For non-specific references, the latest version of the reference document (including any amendments) applies.

- In the case of a reference to a TC SCP document, a non specific reference implicitly refers to the latest version of that document in the same Release as the present document.
- NOTE: While any hyperlinks included in this clause were valid at the time of publication, ETSI cannot guarantee their long term validity.

The following referenced documents are not necessary for the application of the present document but they assist the user with regard to a particular subject area.

Not applicable.

3 Definitions, symbols, abbreviations and coding conventions

3.1 Definitions

For the purposes of the present document, the following terms and definitions apply:

3 V technology Smart Card: Smart Card operating at 3 V \pm 10 % and 5 V \pm 10 %

1,8 V technology Smart Card: Smart Card operating at 1,8 V \pm 10 % and 3 V \pm 10 %

3 V technology Terminal: Terminal operating the Smart Card - Terminal interface at 3 V \pm 10 % and 5 V \pm 10 %

1,8 V technology Terminal: Terminal operating the Smart Card - Terminal interface at 1,8 V \pm 10 % and 3 V \pm 10 %

access conditions: set of security attributes associated with a file

data object: information coded as TLV objects, i.e. consisting of a Tag, a Length and a Value part

Dedicated File (DF): file containing access conditions and, optionally, Elementary Files (EFs) or other Dedicated Files (DFs)

directory: general term for MF, DF and ADF

Elementary File (EF): file containing access conditions and data and no other files

file: directory or an organized set of bytes or records in the UICC

file identifier: 2 bytes which address a file in the UICC

Master File (MF): unique mandatory file containing access conditions and optionally DFs and/or EFs

plug-in UICC: second format of UICC

3.2 Symbols

For the purposes of the present document, the following symbols apply:

f	frequency
Fi	Clock rate conversion factor
Ι	Current
Icc	Current at VCC
Lc	Length of Command data sent by the application layer in a case 3 or 4 Command
Le	Maximum length of data Expected by the application layer in response to a case 2 or 4 Command
Luice	Exact Length of data available in the UICC to be returned in response to the case 2 or 4 Command received by the UICC

t _F	fall time
t _R	rise time
Vcc	Voltage at VCC

3.3 Abbreviations

For the purposes of the present document, the following abbreviations apply:

1 1	
ACK	ACKnowledge
ADF	Application Dedicated File
AID	Application IDentifier
ATR	Answer To Reset
BGT	Block Guard Time
BWI	Block Waiting Integer
BWT	Block Waiting Time
CLK	CLocK
CWI	Character Waiting Integer
CWT	Character Waiting Time
DF	Dedicated File
EDC	Error Detection Code byte
EF	Elementary File
etu	elementary time unit
GND	GrouND
GSM VO	Global System for Mobile communications
I/O I-Block	Input/Output
	Information-Block
ID	IDentifier
IEC	International Electrotechnical Commission
IFSC	Information Field Size for the UICC
IFSD	Information Field Size for the Terminal
INS	INStruction
ISO	International Organization for Standardization
LEN	LENgth
LSB	Least Significant Bit
MF	Master File
MSB	Most Significant Bit
N/A	Not Applicable
NAD	Node ADdress byte
PCB	Protocol Control Byte
PIN	Personal Identification Number
PPS	Protocol and Parameter Selection
R-Block	Receive-ready Block
RFU	Reserved for Future Use
RST	Reset
S-Block	Supervisory-Block
SFI	Short (elementary) File Identifier
TBD	To Be Defined
TE	Terminal Equipment
TLV	Tag Length Value
UE	User Equipment
USIM	Universal Subscriber Identity Module
VCC	Power supply input
WI	Waiting time Integer
WTX	Waiting Time eXtension
WWT	Work Waiting Time

3.4 Coding conventions

For the purposes of the present document, the following coding conventions apply.

All lengths are presented in bytes, unless otherwise stated. Each byte is represented by bits b8 to b1, where b8 is the Most Significant Bit (MSB) and b1 is the Least Significant Bit (LSB). In each representation, the leftmost bit is the MSB.

In the UICC, all bytes specified as RFU is to be set to '00' and all bits specified as RFU are to be set to 0. If the GSM and/or USIM application exists on a UICC or is built on a generic telecommunications card, then other values may apply for the non- GSM or non-USIM applications. The values will be defined in the appropriate specifications for such cards and applications. These bytes and bits are not to be interpreted by a Terminal in a GSM or 3G session.

The coding of all data objects in the present document is according to ETSI TS 102 221 [1]. All data objects are BER-TLV except if otherwise defined.

3.5 Applicability

3.5.1 Applicability of the present document

This present test specification applies to terminal equipment that supports UICC according to ETSI TS 102 221 [1].

3.5.2 Applicability of the individual test cases

Table A.1 lists the optional features for which the supplier of the implementation states the support.

3.5.3 Applicability to terminal equipment

The applicability to terminal equipment specified in table B.1 of the present document applies, unless otherwise specified.

3.6 Definitions

3.6.1 Format of table of the table of optional features

The columns in table A.1 have the following meaning:

Column	Meaning	
Option:	The optional feature supported or not by the implementation.	
Status:	See chapter 3.6.2 'Status and Notations'	
Support:	The support columns are to be filled in by the supplier of the implementation. The following common notations, defined in ISO/IEC 9646-7 [5], are used for the support column in table A.1.	
	Y or y supported by the implementation	
	N or n not supported by the implementation	
	N/A, n/a or - no answer required (allowed only if the status is N/A, directly or after evaluation of a conditional status)	
Х.С		

Mnemonic: The mnemonic column contains mnemonic identifiers for each item.

3.6.2 Format of the applicability table

The applicability of every test in table B.1 is formally expressed by the use of Boolean expression defined in the following clause.

The columns in table B.1 have the following meaning:

Column	Meaning
Test case:	The "Test case" column gives a reference to the test case number(s) detailed in the present document and required to validate the implementation of the corresponding item in the "Description" column
Description:	In the "Description" column a short non-exhaustive description of the requirement is found.
Release:	The "Release" column gives the Release applicable and onwards, for the item in the "Description" column
Rel x TE:	For a given Release, the corresponding "Rel X Terminal" column lists the tests required for a Terminal to be declared compliant to this Release.
Support:	The "Support" column is blank in the proforma, and is to be completed by the manufacturer in respect of each particular requirement to indicate the choices, which have been made in the implementation.

3.6.3 Status and Notations

The "Release X Terminal" columns show the status of the entries as follows:

The following notations, defined in ISO/IEC 9646-7 [5], are used for the status column:

Μ	mandatory - the capability is required to be supported.
0	optional - the capability may be supported or not.
N/A	not applicable - in the given context, it is impossible to use the capability.
Х	prohibited (excluded) - there is a requirement not to use this capability in the given context.
O.i	qualified optional - for mutually exclusive or selectable options from a set. "i" is an integer which identifies an unique group of related optional items and the logic of their selection which is defined immediately following the table.
Ci	conditional - the requirement on the capability ("M", "O", "X" or "N/A") depends on the support of other optional or conditional items. "i" is an integer identifying an unique conditional status expression which is defined immediately following the table. For nested conditional expressions, the syntax "IF THEN (IF THEN ELSE) ELSE" is to be used to avoid ambiguities.

References to items

For each possible item answer (answer in the support column) there exists a unique reference, used, for example, in the conditional expressions. It is defined as the table identifier, followed by a solidus character "/", followed by the item number in the table. If there is more than one support column in a table, the columns are to be discriminated by letters (a, b, etc.), respectively.

EXAMPLE: A.1/4 is the reference to the answer of item 4 in table A.1.

3.7 Table of optional features

Table A.1: Options

Item	Option	Status	Support	Mnemonic
1	ID-1 UICC	0		O_ID1_UICC
2	Plug-in UICC	0		O_PLUG_IN_UICC
3	Class A	0		O_CLASS_A
4	Class B	0		O_CLASS_B
5	Class C	0		O_CLASS_C
6	Compliant to ETSI TS 121 111 [3]	0		O_COMP_121_111
7	Low impedance buffer	0		O_LIB

3.8 Applicability table

Table B.1: Applicability of tests

Test case	Description	Release	R99 TE	Rel-4 TE	Rel-5 TE	Rel-6 TE	Rel-7 TE	Rel-8 TE	Rel-9 TE	Rel-10 TE	Support
4.1	Contact pressure	R99	М	М	М	М	М	М	М	М	
4.2	Curvature of the contacting elements	R99	М	М	М	М	М	М	М	М	
5.1.1	Phase preceding Terminal power on	R99	М	М	М	М	М	М	М	М	
5.1.2.1	Phase during UICC power on: 3 V - 5 V	R99	C001	C001	C001	C001	C001	C001	C001	C001	
5.1.2.2	Phase during UICC power on: 1,8 V - 3 V	R99	C002	C002	C002	C002	C002	C002	C002	C002	
5.1.3.1	Phase during Terminal power off: 3 V - 5 V	R99	C001	C001	C001	C001	C001	C001	C001	C001	
5.1.3.2	Phase during Terminal power off: 1,8 V - 3 V	R99	C002	C002	C002	C002	C002	C002	C002	C002	
5.1.4	Warm reset timing	R99	М	М	М	М	М	М	М	М	
5.1.5.1	Reaction of 3 V technology Terminals on type recognition of 3 V technology UICCs	R99	C001	C001	C001	C001	C001	C001	C001	C001	
5.1.5.2	Reaction of 3 V technology Terminals on type recognition of 1,8 V technology UICCs	R99	C001	C001	C001	C001	C001	C001	C001	C001	
5.1.5.3	Reaction of 1,8 V technology Terminals on type recognition of 1,8 V technology UICCs	R99	C002	C002	C002	C002	C002	C002	C002	C002	
5.1.5.4	Reaction of 1,8 V technology Terminals on type recognition of 3 V technology UICCs	R99	C002	C002	C002	C002	C002	C002	C002	C002	
5.1.5.6.1	Reaction of Terminals receiving no ATR, 3 V - 5 V	R99	C001	C001	C001	C001	C001	C001	C001	C001	
5.1.5.6.2	Reaction of Terminals receiving no ATR, 1.8 V - 3 V	R99	C002	C002	C002	C002	C002	C002	C002	C002	
5.2.2.1	Electrical tests on contact C1, Test 1: 3 V - 5 V	R99	C001	C001	C001	C001	C001	C001	C001	C001	
5.2.2.2	Electrical tests on contact C1, Test 2: 3 V - 5 V	R99	C001	C001	C001	C001	C001	C001	C001	C001	
5.2.2.3	Electrical tests on contact C1, Test 1: 1,8 V - 3 V	R99	C002	C002	C002	C002	C002	C002	C002	C002	
5.2.2.4	Electrical tests on contact C1, Test 2: 1,8 V - 3 V	R99	C002	C002	C002	C002	C002	C002	C002	C002	
5.2.3.1	Electrical tests on contact C2: 3 V - 5 V	R99	C001	C001	C001	C001	C001	C001	C001	C001	
5.2.3.2	Electrical tests on contact C2: 1,8 V - 3 V	R99	C002	C002	C002	C002	C002	C002	C002	C002	
5.2.4.1	Electrical tests on contact C3: 3 V - 5 V	R99	C001	C001	C001	C001	C001	C001	C001	C001	
5.2.4.2	Electrical tests on contact C3: 1,8 V - 3 V	R99	C002	C002	C002	C002	C002	C002	C002	C002	
5.2.5.1	Electrical tests on contact C7, Test 1: 3 V - 5 V	R99	C001	C001	C001	C001	C001	C001	C001	C001	
5.2.5.2	Electrical tests on contact C7, Test 2: 3 V - 5 V	Rel-6	N/A	N/A	N/A	C001	C001	C001	C001	C001	
						AND	AND	AND	AND	AND	
						C007	C007	C007	C007	C007	
5.2.5.3	Electrical tests on contact C7, Test 1: 1,8 V - 3 V	Rel-99	C002	C002	C002	C002	C002	C002	C002	C002	
5.2.5.4	Electrical tests on contact C7, Test 2: 1,8 V - 3 V	Rel-6	N/A	N/A	N/A	C002	C002	C002	C002	C002	
						AND C007	AND C007	AND C007	AND C007	AND C007	
6.1	ATR characters	R99	М	М	М	М	М	М	М	М	
6.2	Clock stop mode with 1,8 V technology UICC	R99	C003	C003	C003	C003	C003	C003	C003	C003	
6.3	Clock stop mode with 3 V technology UICC	R99	C004	C004	C004	C004	C004	C004	C004	C004	
6.5	Speed enhancement	R99	М	М	М	М	М	М	М	М	

Test case	Description	Release	R99	Rel-4	Rel-5	Rel-6	Rel-7	Rel-8	Rel-9	Rel-10	Support
			TE	TE	TE	TE	TE	TE	TE	TE	
7.1.1	Bit/character duration during the transmission from the Terminal to the UICC	R99	M	М	М	М	М	М	М	М	
7.1.2	Bit/character duration during the transmission from the UICC to the Terminal	R99	М	М	М	М	М	М	М	М	
7.2.1	Timing	R99	М	М	М	М	М	М	М	М	
7.2.2	Command processing, ACK, NACK, NULL procedure bytes	R99	М	М	М	М	М	М	М	М	
7.2.3	Case 2 command, use of procedure bytes '61xx' and '6Cxx'	R99	М	М	М	М	М	М	М	М	
7.2.4	Case 4 command, use of procedure bytes '61xx'	R99	М	М	М	М	М	М	М	М	
7.2.5	Command processing, warning and error status bytes	R99	М	М	М	М	М	М	М	М	
7.2.6	Error correction	R99	М	М	М	М	М	М	М	М	
7.2.7	Error detection	R99	М	М	М	М	М	М	М	М	
7.3.1	Character Waiting Time	R99	М	М	М	М	М	М	М	М	
7.3.2	Block Timing	R99	М	М	М	М	М	М	М	М	
7.3.3	Block Waiting Time extension	R99	М	М	М	М	М	М	М	М	
7.3.4	Chaining - Respect of IFSC by Terminal	R99	М	М	М	М	М	М	М	М	
7.3.5	Chaining - IFSD management	R99	М	М	М	М	М	М	М	М	
7.3.6	I-Block error correction	R99	М	М	М	М	М	М	М	М	
7.3.7	I-Block error detection	R99	М	М	М	М	М	М	М	М	
7.3.8	R-Block error handling in non-chaining mode	R99	М	М	М	М	М	М	М	М	
7.3.9	R-Block error handling in chaining mode	R99	М	М	М	М	М	М	М	М	
7.3.10	Successive errors in both directions	R99	М	М	М	М	М	М	М	М	
7.3.11	Chaining - Abortion	R99	М	М	М	М	М	М	М	М	
7.3.12	Block repetition and resynchronization	R99	М	М	М	М	М	М	М	М	
7.3.13	UICC is unresponsive	R99	М	М	М	М	М	М	М	М	
8.1	UICC presence detection	R99	М	М	N/A	N/A	N/A	N/A	N/A	N/A	
C001	F (O_CLASS_A AND O_CLASS_B AND NOT O_COMP_121.111) THEN M	ELSE N/A.									
	F (O_CLASS_B AND O_CLASS_C) THEN M ELSE N/A.										
	F O_CLASS_C THEN M ELSE N/A.										
	F O_CLASS_B THEN M ELSE N/A.										
	F O_SPEED_512-8_512-16 THEN M ELSE N/A.										
	void										
C007	F O_LIB THEN M ELSE N/A.										

18

4 Physical characteristic tests

4.1 Contact pressure

4.1.1 Definition and applicability

The contact pressure shall be large enough to ensure reliable and continuous contact (e.g. to overcome oxidization and to prevent interruption caused by vibration).

For applicability of this test case see clause 3.8.

4.1.2 Conformance requirement

Under no circumstances shall the contact force exceed 0,5 N per contact.

4.1.2.1 Reference

ETSI TS 102 221 [1], clause 4.4.4.

4.1.3 Test purpose

To verify that the contact pressure of each contacting element is not greater than 0,5 N when each of the following types of card is used:

- 1) Unembossed.
- 2) Embossed on the contact side.

NOTE: Only type 1) applies to the plug-in UICC.

4.1.4 Method of test

4.1.4.1 Initial conditions

The Terminal manufacturers shall provide, if possible, a separate card reader (mechanical components) to allow measurements.

4.1.4.2 Procedure

The pressure of each contacting element is measured.

4.1.5 Acceptance criteria

The contact force shall not exceed 0,5 N per contact.

4.2 Curvature of the contacting elements

4.2.1 Definition and applicability

The contact pressure shall be large enough to ensure reliable and continuous contact (e.g. to overcome oxidization and to prevent interruption caused by vibration).

For applicability of this test case see clause 3.8.

4.2.2 Conformance requirement

The radius of any curvature of the contacting elements shall be greater than or equal to 0,8 mm over the contact area.

4.2.2.1 Reference

ETSI TS 102 221 [1], clause 4.4.4.

4.2.3 Test purpose

To verify that the radius of curvature of the contacting elements is greater than or equal to 0,8 mm over the contact area.

4.2.4 Method of test

4.2.4.1 Initial conditions

The Terminal manufacturers shall provide, if possible, a separate card reader (mechanical components) to allow measurements.

4.2.4.2 Procedure

The radius of curvature of the contacting elements is measured on both axes.

4.2.5 Acceptance criteria

The radius of any curvature of the contacting elements shall be greater than or equal to 0,8 mm over the contact area.

5 Electrical characteristic tests

5.1 Test of the power transition phases

5.1.1 Phase preceding Terminal power on

5.1.1.1 Definition and applicability

When the mobile equipment is switched off, the contacts of the UICC-Terminal interface remain in an inactive state in order to prevent any damage to the UICC.

For applicability of this test case see clause 3.8.

5.1.1.2 Conformance requirement

The residual voltage across the contacts of the UICC-Terminal interface (C1, C2, C3, C7) shall not exceed ± 0.4 V referenced to GND.

5.1.1.3 Reference

ETSI TS 102 221 [1], clause 4.4.3.

5.1.1.4 Test purpose

To verify that the residual voltage across the contacts of the UICC-Terminal interface (C1, C2, C3, C7) is not greater than ± 0.4 V referenced to GND.

5.1.1.5 Method of test

5.1.1.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The contact C1 (VCC) of the UICC-Terminal interface shall be loaded with an impedance of 10 k Ω .

The other contacts (C2, C3, C7) shall be loaded with an impedance of 50 k Ω .

5.1.1.5.2 Procedure

The residual voltage on each contact shall be measured.

5.1.1.6 Acceptance criteria

The residual voltage on each contact shall not exceed ± 0.4 V referenced to GND.

5.1.2 Phase during UICC power on

5.1.2.1 Phase during UICC power on: 3 V - 5 V

5.1.2.1.1 Definition and applicability

When the user equipment is switched on or when the UICC-Terminal interface is being activated after supply voltage switching, the contacts shall be activated in a defined sequence in order to prevent any damage to the UICC.

A 3 V technology Terminal may switch from 3 V to 5 V after it has analysed the ATR and identified the UICC voltage class by deactivating the UICC and activating it at the new supply voltage.

For applicability of this test case see clause 3.8.

5.1.2.1.2 Conformance requirement

- 1) When the UE is soft powered on, the contacts of the UICC-Terminal interface shall be activated to 3 V mode in the following order:
 - 1 VCC at state H and stable;
 - 2 CLK stable;
 - 3 RST at state L for at least 400 clock cycles after the clock signal is applied to CLK;
 - 4 I/O at state Z within 200 clock cycles after the clock signal is applied to CLK.
- 2) When the UICC Terminal interface is being activated after the 3 V/5 V switching the contacts shall be activated to 5 V mode in the order given in 1).

5.1.2.1.3 Reference

ETSI TS 102 221 [1], clause 4.4.2.

5.1.2.1.4 Test purpose

To verify that the contacts of the UICC-Terminal interface are activated in the correct order, as described in the conformance requirement.

5.1.2.1.5 Method of test

5.1.2.1.5.1 Initial condition

The Terminal shall be connected to an UICC-Terminal simulator.

5.1.2.1.5.2 Procedure

To test the requirements 1), the UE shall be soft powered on.

To test the requirement 2), the Terminal shall be caused to switch the voltage on the UICC-Terminal interface.

The verification of the activation procedure shall be started with the first contact leaving the inactive state. The UICC-Terminal interface shall be monitored until it is fully activated.

5.1.2.1.6 Acceptance criteria

The contacts of the UICC-Terminal interface shall be activated in the correct order, as described in the conformance requirement.

5.1.2.2 Phase during UICC power on: 1,8 V - 3 V

5.1.2.2.1 Definition and applicability

When the user equipment is switched on or when the UICC-Terminal interface is being activated after supply voltage switching, the contacts shall be activated in a defined sequence in order to prevent any damage to the UICC.

A 1,8 V technology Terminal may switch from 1,8 V to 3 V after it has analysed the ATR and identified the UICC voltage class by deactivating the UICC and activating it at the new supply voltage.

For applicability of this test case see clause 3.8.

5.1.2.2.2 Conformance requirement

- 1) When the UE is soft powered on, the contacts of the UICC-Terminal interface shall be activated to 1,8 V mode in the following order:
 - 1 VCC at state H and stable;
 - 2 CLK stable;
 - 3 RST at state L for at least 400 clock cycles after the clock signal is applied to CLK;
 - 4 I/O at state Z within 200 clock cycles after the clock signal is applied to CLK.
- 2) When the UICC Terminal interface is being activated after the 1,8 V/3 V switching the contacts shall be activated to 3 V mode in the order given in 1).

5.1.2.2.3 Reference

ETSI TS 102 221 [1], clause 4.4.2.

5.1.2.2.4 Test purpose

To verify that the contacts of the UICC-Terminal interface are activated in the correct order, as described in the conformance requirement.

5.1.2.2.5 Method of test

5.1.2.2.5.1 Initial condition

The Terminal shall be connected to an UICC-Terminal simulator.

5.1.2.2.5.2 Procedure

To test the requirement 1), the UE shall be soft powered on.

To test the requirement 2), the Terminal shall be caused to switch the voltage on the UICC-Terminal interface.

The verification of the activation procedure shall be started with the first contact leaving the inactive state. The UICC-Terminal interface shall be monitored until it is fully activated.

5.1.2.2.6 Acceptance criteria

The contacts of the UICC-Terminal interface shall be activated in the correct order, as described in the conformance requirement.

5.1.3 Phase during Terminal power off

5.1.3.1 Phase during Terminal power off: 3 V - 5 V

5.1.3.1.1 Definition and applicability

When the user equipment is soft powered off or when the UICC-Terminal interface is being deactivated for 3 V/5 V switching, the contacts shall be deactivated in a defined sequence in order to prevent any damage to the UICC.

NOTE: If during UE operation the UICC is physically removed it is impractical to ensure correct sequencing of deactivation and the possible damage to the UICC cannot be safeguarded by a type approval test. Furthermore, in this situation the integrity of the UICC data is not guaranteed.

For applicability of this test case see clause 3.8.

5.1.3.1.2 Conformance requirement

1) Depending on the state of the clock at the time of deactivation, the contacts of the UICC-Terminal shall be deactivated in one of two ways.

If the clock is running, the contacts of the UICC-Terminal interface shall be deactivated in the following order:

- 1 RST at low level;
- 2 Clock stopped at low level;
- 3 I/O at status A;
- 4 VCC inactive.

If the clock is stopped and is not restarted, the Terminal is allowed to deactivate all the contacts in any order, provided that all signals reach low level before Vcc leaves high level.

2) When the UICC - Terminal interface is deactivated for 3 V/5 V switching, the contacts shall be deactivated as given in 1).

5.1.3.1.3 Reference

ETSI TS 102 221 [1], clause 4.4.2.

5.1.3.1.4 Test purpose

To verify that, depending on the state of the clock (running or stopped), the contacts of the UICC-Terminal interface become deactivated in the correct order, as given in the conformance requirement.

5.1.3.1.5 Method of test

5.1.3.1.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The UICC characteristics of the directories (see ETSI TS 102 221 [1], clause 11.1.1.4.6.1) shall indicate that clock stop is allowed.

5.1.3.1.5.2 Procedure

To test the requirements 1), the UE shall be soft powered off.

To test the requirement 2), the Terminal shall be caused to switch the voltage on the UICC-Terminal interface.

The UICC-Terminal interface shall be monitored until it is fully deactivated.

5.1.3.1.6 Acceptance criteria

The contacts of the UICC-Terminal interface shall be deactivated in the correct order, as given in the conformance requirements.

5.1.3.2 Phase during Terminal power off: 1.8 V - 3 V

5.1.3.2.1 Definition and applicability

When the user equipment is soft powered off or when the UICC-Terminal interface is being deactivated for 1,8 V/3 V switching, the contacts shall be deactivated in a defined sequence in order to prevent any damage to the UICC.

NOTE: If during UE operation the UICC is physically removed it is impractical to ensure correct sequencing of deactivation and the possible damage to the UICC cannot be safeguarded by a type approval test. Furthermore, in this situation the integrity of the UICC data is not guaranteed.

For applicability of this test case see clause 3.8.

5.1.3.2.2 Conformance requirement

1) Depending on the state of the clock at the time of deactivation, the contacts of the UICC-Terminal shall be deactivated in one of two ways.

If the clock is running, the contacts of the UICC-Terminal interface shall be deactivated in the following order:

- 1 RST at low level;
- 2 Clock stopped at low level;
- 3 I/O at status A;
- 4 VCC inactive.

If the clock is stopped and is not restarted, the Terminal is allowed to deactivate all the contacts in any order, provided that all signals reach low level before Vcc leaves high level.

2) When the UICC-Terminal interface is deactivated for 1,8 V/3 V switching, the contacts shall be deactivated as given in 1).

5.1.3.2.3 Reference

ETSI TS 102 221 [1], clause 4.4.2.

5.1.3.2.4 Test purpose

To verify that, depending on the state of the clock (running or stopped), the contacts of the UICC-Terminal interface become deactivated in the correct order, as given in the conformance requirement.

5.1.3.2.5 Method of test

5.1.3.2.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The UICC characteristics of the directories (see ETSI TS 102 221 [1], clause 11.1.1.4.6.1) shall indicate that clock stop is allowed.

5.1.3.2.5.2 Procedure

To test the requirement 1), the UE shall be soft powered off.

To test the requirement 2), the Terminal shall be caused to switch the voltage on the UICC-Terminal interface.

The UICC-Terminal interface shall be monitored until it is fully deactivated.

5.1.3.2.6 Acceptance criteria

The contacts of the UICC-Terminal interface shall be deactivated in the correct order, as given in the conformance requirements.

5.1.4 Warm reset timing

5.1.4.1 Definition and applicability

The warm reset is performed according to clause 5.3.3 of ISO/IEC 7816-3 [2] and the UICC shall enter either the negotiable or the specific mode.

For applicability of this test case see clause 3.8.

5.1.4.2 Conformance requirement

- 1) VCC at state H and stable.
- 2) CLK stable.
- 3) RST at state H.
- 4) RST at state L for 400 clock cycles.
- 5) RST at state H for at least 400 clock cycles.
- 6) RST at state H for 40 000 clock cycles before deactivation if no answer is received.

5.1.4.2.1 Reference

ETSI TS 102 221 [1], clause 6.6.

ISO/IEC 7816-3 [2], clause 5.3.3.

5.1.4.3 Test purpose

To verify that the contacts of the UICC-Terminal interface are activated in the correct order, as described in the conformance requirement.

5.1.4.4 Method of test

5.1.4.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator.

5.1.4.4.2 Procedure

- a) The Terminal shall be made to initiate a warm reset (TBD).
- b) The UICC simulator shall send a valid ATR:
 - b-1) 400 clock cycles after RST is set to state H.
 - b-2) 39 990 clock cycles after RST is set to state H. The contacts of the UICC-Terminal interface shall be monitored during the warm reset sequence.

5.1.4.5 Acceptance criteria

The Terminal shall perform a warm reset as described in the conformance requirement.

In steps b-1) and b-2) the Terminal shall read the answer to the warm reset and work with the UICC.

5.1.5 UICC type recognition and voltage switching

5.1.5.1 Reaction of 3 V technology Terminals on type recognition of 3 V technology UICCs

5.1.5.1.1 Definition and applicability

When a 3 V technology Terminal detects a 3 V technology UICC during the ATR analysis the Terminal may either switch to 5 V operation or stay in 3 V operation.

For applicability of this test case see clause 3.8.

5.1.5.1.2 Conformance requirement

- 1) A 3 V technology Terminal shall initially activate the UICC with 3 V (i.e. the first activation of a card session).
- 2) The Terminal shall analyse the ATR and identify the voltage class supported by the UICC.
- 3) If a 3 V technology Terminal identifies a 3 V technology UICC the Terminal may switch to 5 V operation. Switching from 3 V to 5 V shall only be performed by deactivating the UICC and activating it with 5 V supply voltage immediately after the analysis of the ATR without issuing any commands.

5.1.5.1.3 Reference

ETSI TS 102 221 [1], clause 6.2.

5.1.5.1.4 Test purpose

- 1) To verify that a 3 V technology Terminal initially activates the UICC with 3 V.
- 2) To verify that a 3 V technology Terminal correctly identifies the voltage class.
- 3) To verify that a 3 V technology Terminal deactivates the UICC-Terminal interface immediately after the analysis of the ATR without issuing any command and activates it with 5 V supply voltage or proceeds with the 3 V operation during the whole card session without switching to 5 V supply voltage.

5.1.5.1.5 Method of test

5.1.5.1.5.1 Initial condition

The Terminal shall be connected to an UICC simulator simulating a 3 V technology UICC with nominal test conditions (see clause 5.2.1). All elementary files shall be coded as default.

The Terminal shall be powered on.

5.1.5.1.5.2 Procedure

The UICC simulator shall send an ATR indicating a 3 V technology UICC.

The UICC-Terminal interface shall be monitored for at least 1 minute until the UE is switched off.

5.1.5.1.6 Acceptance criteria

- 1) The initial activation of the UICC-Terminal interface shall be performed with 3 V supply voltage.
- 2) The Terminal shall react in one of the following ways:
 - a) The Terminal deactivates the UICC-Terminal interface immediately after the receipt of the ATR from the UICC and activates it with 5 V supply voltage.
 - b) The Terminal proceeds with the card session without switching to another supply voltage.

5.1.5.2 Reaction of 3 V technology Terminals on type recognition of 1,8 V technology UICCs

5.1.5.2.1 Definition and applicability

When a 3 V technology Terminal detects a 1,8 V technology UICC during the ATR analysis the Terminal shall stay in 3 V operation.

For applicability of this test case see clause 3.8.

5.1.5.2.2 Conformance requirement

- 1) A 3 V technology Terminal shall initially activate the UICC with 3 V (i.e. the first activation of a card session).
- 2) The Terminal shall analyse the ATR and identify the voltage class supported by the UICC.
- 3) If a 3 V technology Terminal identifies a 1,8 V technology UICC during the ATR analysis the Terminal shall stay in 3 V operation.

5.1.5.2.3 Reference

ETSI TS 102 221 [1], clause 6.2.

5.1.5.2.4 Test purpose

- 1) To verify that a 3 V technology Terminal initially activates the UICC with 3 V.
- 2) To verify that a 3 V technology Terminal correctly identifies the voltage class.
- 3) To verify that a 3 V technology Terminal stays in 3 V operation during the whole card session.

5.1.5.2.5 Method of test

5.1.5.2.5.1 Initial condition

The Terminal shall be connected to an UICC simulator simulating a 1,8 V technology UICC with nominal test conditions (see clause 5.2.1). All elementary files shall be coded as default.

The Terminal shall be powered on.

5.1.5.2.5.2 Procedure

The UICC simulator shall send an ATR indicating a 1,8 V technology UICC.

The UICC-Terminal interface shall be monitored for at least 1 minute until the UE is switched off.

5.1.5.2.6 Acceptance criteria

- 1) The initial activation of the UICC-Terminal interface shall be performed with 3 V supply voltage.
- 2) The Terminal shall react in the following way:
 - The Terminal proceeds with the card session without switching to another supply voltage.

5.1.5.3 Reaction of 1,8 V technology Terminals on type recognition of 1,8 V technology UICCs

5.1.5.3.1 Definition and applicability

When a 1,8 V technology Terminal detects a 1,8 V technology UICC during the ATR analysis the Terminal may either switch to 3 V operation or stay in 1,8 V operation.

For applicability of this test case see clause 3.8.

5.1.5.3.2 Conformance requirement

- 1) A 1,8 V technology Terminal shall initially activate the UICC with 1,8 V (i.e. the first activation of a card session).
- 2) The Terminal shall analyse the ATR and identify the voltage class supported by the UICC.
- 3) If a 1,8 V technology Terminal identifies a 1,8 V technology UICC the Terminal may switch to 3 V operation. Switching from 1,8 V to 3 V shall only be performed by deactivating the UICC and activating it with 3 V supply voltage immediately after the analysis of the ATR without issuing any commands.

5.1.5.3.3 Reference

ETSI TS 102 221 [1], clause 6.2.

5.1.5.3.4 Test purpose

- 1) To verify that a 1,8 V technology Terminal initially activates the UICC with 1,8 V.
- 2) To verify that a 1,8 V technology Terminal correctly identifies the voltage class.
- 3) To verify that a 1,8 V technology Terminal deactivates the UICC-Terminal interface immediately after the analysis of the ATR without issuing any command and activates it with 3 V supply voltage or proceeds with the 1,8 V operation during the whole card session without switching to 3 V supply voltage.

5.1.5.3.5 Method of test

5.1.5.3.5.1 Initial condition

The Terminal shall be connected to an UICC simulator simulating a 1,8 V technology UICC with nominal test conditions (see clause 5.2.1). All elementary files are coded as default.

The Terminal shall be powered on.

5.1.5.3.5.2 Procedure

The UICC simulator shall send the ATR indicating a 3 V technology UICC.

The UICC-Terminal interface shall be monitored for at least 1 minute until the UE is switched off.

5.1.5.3.6 Acceptance criteria

- 1) The initial activation of the UICC-Terminal interface shall be performed with 1,8 V supply voltage.
- 2) The Terminal shall react in one of the following ways:
 - a) The Terminal deactivates the UICC-Terminal interface immediately after the analysis of the ATR from the UICC and activates it with 3 V supply voltage.
 - b) The Terminal proceeds with the card session without switching to another supply voltage.
- 5.1.5.4 Reaction of 1,8 V technology Terminals on type recognition of 3 V technology UICCs

5.1.5.4.1 Definition and applicability

When a 1,8 V technology Terminal detects a 3 V technology UICC during the ATR analysis the Terminal shall switch to 3 V operation.

For applicability of this test case see clause 3.8.

5.1.5.4.2 Conformance requirement

- 1) A 1,8 V technology Terminal shall initially activate the UICC with 1,8 V (i.e. the first activation of a card session).
- 2) The Terminal shall analyse the ATR and identify the voltage class supported by the UICC.

3) If a 1,8 V technology Terminal identifies a 3 V technology UICC the Terminal shall switch to 3 V operation. Switching from 1,8 V to 3 V shall only be performed by deactivating the UICC and activating it with 3 V supply voltage immediately after the analysis of the ATR without issuing any commands.

5.1.5.4.3 Reference

ETSI TS 102 221 [1], clause 6.2.

5.1.5.4.4 Test purpose

- 1) To verify that a 1,8 V technology Terminal initially activates the UICC with 1,8 V.
- 2) To verify that a 1,8 V technology Terminal correctly identifies the voltage class.
- 3) To verify that a 1,8 V technology Terminal deactivates the UICC-Terminal interface immediately after the recognition of a 3 V technology UICC (in order to switch the supply voltage).
- 4) To verify that a 1,8 V technology Terminal activates the UICC with 3 V.

5.1.5.4.5 Method of test

5.1.5.4.5.1 Initial condition

The Terminal shall be connected to an UICC simulator simulating a 3 V technology UICC with nominal test conditions (see clause 5.2.1). All elementary files are coded as default.

The Terminal shall be powered on.

5.1.5.4.5.2 Procedure

The UICC simulator shall send the ATR indicating a 3 V technology UICC.

The UICC-Terminal interface shall be monitored for at least 1 minute until the UE is switched off.

5.1.5.4.6 Acceptance criteria

- 1) The initial activation of the UICC-Terminal interface shall be performed with 1,8 V supply voltage.
- 2) The Terminal shall react in the following way:
 - The Terminal deactivates the UICC-Terminal interface immediately after the analysis of the ATR from the UICC and activates it with 3 V supply voltage. The Terminal proceeds with the card session.
- 5.1.5.5 Void
- 5.1.5.6 Reaction of Terminals receiving no ATR
- 5.1.5.6.1 Reaction of Terminals receiving no ATR, 3 V 5 V
- 5.1.5.6.1.1 Definition and applicability

A Terminal supporting 3 V - 5 V shall initially activate the UICC with 3V. If no ATR is received, the UICC-Terminal interface shall be deactivated and activated with 5V.

For applicability of this test case see clause 3.8.

5.1.5.6.1.2 Conformance requirement

If a Terminal does not receive an ATR, the Terminal shall deactivate the UICC-Terminal interface and repeat the activation with the next higher voltage class.

5.1.5.6.1.3 Reference

ETSI TS 102 221 [1], see clause 6.2.

5.1.5.6.1.4 Test purpose

To verify that a Terminal deactivates the UICC-Terminal interface and repeats the activation with the next higher voltage class in case that the Terminal cannot receive an ATR.

5.1.5.6.1.5 Method of test

5.1.5.6.1.5.1 Initial condition

The Terminal shall be connected to an UICC simulator. All elementary files shall be coded as default. The Terminal shall be powered on.

5.1.5.6.1.5.2 Procedure

The UICC simulator shall send no ATR.

5.1.5.6.1.6 Acceptance criteria

If no ATR is received by the Terminal, the Terminal shall wait at least 40 000 clock cycles before deactivating the UICC-Terminal interface. The Terminal shall then repeat the activation procedure with the next higher voltage class.

5.1.5.6.2 Reaction of Terminals receiving no ATR, 1,8 V - 3 V

5.1.5.6.2.1 Definition and applicability

A Terminal supporting 1,8 V - 3 V shall initially activate the UICC with 1,8 V. If no ATR is received, the UICC-Terminal interface shall be deactivated and activated with 3 V.

For applicability of this test case see clause 3.8.

5.1.5.6.2.2 Conformance requirement

If a Terminal does not receive an ATR, the Terminal shall deactivate the UICC-Terminal interface and repeat the activation with the next higher voltage class.

5.1.5.6.2.3 Reference

ETSI TS 102 221 [1], see clause 6.2.

5.1.5.6.2.4 Test purpose

To verify that a Terminal deactivates the UICC-Terminal interface and repeats the activation with the next higher voltage class in case that the Terminal cannot receive an ATR.

- 5.1.5.6.2.5 Method of test
- 5.1.5.6.2.5.1 Initial condition

The Terminal shall be connected to an UICC simulator. All elementary files shall be coded as default. The Terminal shall be powered on.

5.1.5.6.2.5.2 Procedure

The UICC simulator shall send no ATR.

5.1.5.6.2.6 Acceptance criteria

If no ATR is received by the Terminal, the Terminal shall wait at least 40 000 clock cycles before deactivating the UICC-Terminal interface. The Terminal shall then repeat the activation procedure with the next higher voltage class.

5.2 Electrical tests on each Terminal contact

5.2.1 Nominal test conditions

Tables 5.1 to 5.3 give the electrical conditions that shall be applied by the UICC simulator to all contacts during a test if not stated otherwise.

Contacts	Low level	High level	Max. capacitive load
C1 (VCC)		l = 10 mA	
C2 (RST)	I = -200 μA	I = +20 μA	30 pF
C3 (CLK)	I = -200 μA	I = +20 μA	30 pF
C5 (GND)			
C7 (I/O)			30 pF
Terminal input	I = +1 mA	I = +20 μA	
Terminal output	I = -1 mA	I = +20 μA	

Table 5.1: Nominal test conditions on 5V UICC - Terminal interface

Table 5.2: Nominal test conditions on 3 V UICC-Terminal interface

Contacts	Low level	High level	Max. capacitive load
C1 (VCC)		l = 7.5 mA	
C2 (RST)	I = -200 μA	I = +20 μA	30 pF
C3 (CLK)	I = -20 μA	I = +20 μA	30 pF
C5 (GND)			
C7 (I/O)			30 pF
Terminal input	I = +1 mA	I = +20 μA	
Terminal output	l = -1 mA	I = +20 μA	

Table 5.3: Nominal test conditions on 1,8 V UICC-Terminal interface

Contacts	Low level	High level	Max. capacitive load
C1 (VCC)		l = 5 mA	
C2 (RST)	I = -200 μA	I = +20 μA	30 pF
C3 (CLK)	I = -20 μA	I = +20 μA	30 pF
C5 (GND)			
C7 (I/O)			30 pF
Terminal input	I = +1 mA	I = +20 μA	
Terminal output	I = -1 mA	I = +20 μA	

- NOTE 1: Measurements of contacts voltage levels can be done at any time since the beginning of activation of the UICC and the end of deactivation of the UICC (ISO/IEC 7816-3 [2], clause 5.1).
- NOTE 2: The reference point of all measurements is the contact C5 (Ground).
- NOTE 3: Currents flowing into the UICC are considered positive.

5.2.2 Electrical tests on contact C1

C1 = Card power supply (VCC).

5.2.2.1 Electrical tests on contact C1, Test 1: 3 V - 5 V

5.2.2.1.1 Definition and applicability

When the user equipment is activated, the supply voltage on the UICC -Terminal interface shall remain in the specified range in order to ensure correct operation and to prevent any damage to the UICC.

For applicability of this test case see clause 3.8.

5.2.2.1.2 Conformance requirement

- 1) The voltage on contact C1 of the UICC-Terminal interface shall be 5 V \pm 10 % for Icc up to 10 mA when the Terminal is in 5 V operation mode.
- 2) The voltage on contact C1 of the UICC-Terminal interface shall be $3 V \pm 10 \%$ for Icc up to 10 mA when the Terminal is in 3 V operation mode.

5.2.2.1.3 Reference

- 1) ETSI TS 102 221 [1], clause 5.1.
- 2) ETSI TS 102 221 [1], clause 5.2.

5.2.2.1.4 Test purpose

To verify that the Terminal keeps the voltage on contact C1 of the UICC-Terminal interface within the ranges specified in the conformance requirements.

5.2.2.1.5 Method of test

5.2.2.1.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The UE shall be activated.

The remaining contacts of the UICC-Terminal interface shall be in nominal test conditions (see clause 5.2.1).

5.2.2.1.5.2 Test Procedure

The voltage of contact C1 (VCC) of the UICC-Terminal interface shall be measured.

5.2.2.1.6 Acceptance criteria

The voltage on contact C1 of the UICC-Terminal interface shall be within the ranges specified in the conformance requirements.

5.2.2.2 Electrical tests on contact C1, Test 2: 3 V - 5 V

5.2.2.2.1 Definition and applicability

When the user equipment is activated, the supply voltage on the UICC-Terminal interface shall be able to counteract spikes in the current consumption of the UICC up to the limits given in the conformance requirement, ensuring that the supply voltage stays in the specified range.

For applicability of this test case see clause 3.8.

5.2.2.2.2 Conformance requirement

- 1) The voltage on contact C1 of the UICC-Terminal interface shall be 5 V \pm 10 % for spikes in the current consumption with a maximum charge of 40 n. As with no more than 400 ns duration and an amplitude of at most 200 mA when the Terminal is in 5 V operation mode.
- 2) The voltage on contact C1 of the UICC-Terminal interface shall be $3 V \pm 10 \%$ for spikes in the current consumption with a maximum charge of 12 n. As with no more than 400 ns duration and an amplitude of at most 60 mA when the Terminal is in 3 V operation mode.

5.2.2.2.3 Reference

- 1) ETSI TS 102 221 [1], clause 5.1.
- 2) ETSI TS 102 221 [1], clause 5.2.

5.2.2.2.4 Test purpose

To verify that the Terminal keeps the voltage on contact C1 of the UICC-Terminal interface within the specified range for the conditions given in the UICC-Terminal conformance requirement.

- 5.2.2.5 Method of test
- 5.2.2.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The UE shall be activated.

The remaining contacts of the interface shall held in nominal test condition (see clause 5.2.1).

5.2.2.5.2 Procedure

In order to test the requirements 1), the voltage on contact C1 of the UICC-Terminal interface shall be monitored and the following current spikes shall be applied:

- 1) continuous spikes:
 - current amplitude 20 mA;
 - current offset 0 mA;
 - duration 100 ns;
 - pause 100 ns.
- 2) continuous spikes:
 - current 20 mA;
 - current offset 0 mA;
 - duration 400 ns;
 - pause 400 ns.
- 3) continuous spikes:
 - current amplitude 15 mA;
 - current offset 5 mA;
 - (i.e. maximum amplitude = 5 mA + 15 mA = 20 mA);
 - duration 150 ns;
 - pause 300 ns.
- 4) random spikes:
 - current amplitude 200 mA;
 - current offset 0 mA;
 - duration 200 ns;
 - pause between 0,1 ms and 500 ms, randomly varied.
- 5) random spikes:
 - current amplitude 100 mA;
 - current offset 0 mA;
 - duration 400 ns;

- pause between 0,1 ms and 500 ms, randomly varied.
- 6) random spikes:
 - current amplitude 195 mA;
 - current offset 5mA;
 - (i.e. maximum amplitude = 5 mA + 195 mA = 200 mA);
 - Duration 200 ns;
 - Pause between 0,1 ms and 500 ms, randomly varied.

In order to test the requirements 2), the voltage on contact C1 of the UICC-Terminal interface shall be monitored and the following current spikes shall be applied:

- 1) continuous spikes:
 - current amplitude 12 mA;
 - current offset 0 mA;
 - duration 100 ns;
 - pause 100 ns.
- 2) continuous spikes:
 - current 12 mA;
 - current offset 0 mA;
 - duration 400 ns;
 - pause 400 ns.
- 3) continuous spikes:
 - current amplitude 9 mA;
 - current offset 3 mA;
 - (i.e. maximum amplitude = 3 mA + 9 mA = 12 mA);
 - duration 150 ns;
 - pause 300 ns.
- 4) random spikes:

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- current amplitude 60 mA;
- current offset 0 mA;
- duration 200 ns;
- pause between 0,1 ms and 500 ms, randomly varied.
- 5) random spikes:
 - current amplitude 30 mA;
 - current offset 0 mA;
 - duration 400 ns;
 - pause between 0,1 ms and 500 ms, randomly varied.

- 6) random spikes:
 - current amplitude 57 mA;
 - current offset 3 mA;
 - (i.e. maximum amplitude = 3 mA + 57 mA = 60 mA);
 - duration 200 ns;
 - pause between 0,1 ms and 500 ms, randomly varied.

The specified spike durations shall be measured at 50 % of the spike amplitude.

5.2.2.2.6 Acceptance criteria

The voltage on contact C1 of the UICC-Terminal interface shall be within the ranges specified in the conformance requirements.

5.2.2.3 Electrical tests on contact C1, Test 1: 1,8 V - 3 V

5.2.2.3.1 Definition and applicability

When the user equipment is activated, the supply voltage on the UICC -Terminal interface shall remain in the specified range in order to ensure correct operation and to prevent any damage to the UICC.

For applicability of this test case see clause 3.8.

5.2.2.3.2 Conformance requirement

- 1) The voltage on contact C1 of the UICC-Terminal interface shall be $3 V \pm 10 \%$ for Icc up to 10 mA when the Terminal is in 3 V operation mode.
- 2) The voltage on contact C1 of the UICC-Terminal interface shall be $1.8 \text{ V} \pm 10 \%$ for Icc up to 10 mA when the Terminal is in 1.8 V operation mode.

5.2.2.3.3 Reference

- 1) ETSI TS 102 221 [1], clause 5.2.
- 2) ETSI TS 102 221 [1], clause 5.3.

5.2.2.3.4 Test purpose

To verify that the Terminal keeps the voltage on contact C1 of the UICC-Terminal interface within the ranges specified in the conformance requirements.

5.2.2.3.5 Method of test

5.2.2.3.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The UE shall be activated.

The remaining contacts of the UICC-Terminal interface shall be in nominal test conditions (see clause 5.2.1).

5.2.2.3.5.2 Test Procedure

The voltage of contact C1 (VCC) of the UICC-Terminal interface shall be measured.

5.2.2.3.6 Acceptance criteria

The voltage on contact C1 of the UICC-Terminal interface shall be within the ranges specified in the conformance requirements.

5.2.2.4 Electrical tests on contact C1, Test 2: 1,8 V - 3 V

5.2.2.4.1 Definition and applicability

When the user equipment is activated, the supply voltage on the UICC-Terminal interface shall be able to counteract spikes in the current consumption of the UICC up to the limits given in the conformance requirement, ensuring that the supply voltage stays in the specified range.

For applicability of this test case see clause 3.8.

5.2.2.4.2 Conformance requirement

- 1) The voltage on contact C1 of the UICC-Terminal interface shall be $3 V \pm 10 \%$ for spikes in the current consumption with a maximum charge of 12 n. As with no more than 400 ns duration and an amplitude of at most 60 mA when the Terminal is in 3 V operation mode.
- 2) The voltage on contact C1 of the UICC-Terminal interface shall be 1,8 V ± 10 % for spikes in the current consumption with a maximum charge of 12 n. As with no more than 400 ns duration and an amplitude of at most 60 mA when the Terminal is in 1,8 V operation mode.

5.2.2.4.3 Reference

- 1) ETSI TS 102 221 [1], clause 5.2.
- 2) ETSI TS 102 221 [1], clause 5.3.

5.2.2.4.4 Test purpose

To verify that the Terminal keeps the voltage on contact C1 of the UICC-Terminal interface within the specified range for the conditions given in the UICC-Terminal conformance requirement.

5.2.2.4.5 Method of test

5.2.2.4.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The UE shall be activated.

The remaining contacts of the interface shall held in nominal test condition (see clause 5.2.1).

5.2.2.4.5.2 Procedure

In order to test the requirements 1) and 2), the voltage on contact C1 of the UICC-Terminal interface shall be monitored and the following current spikes shall be applied:

- 1) continuous spikes:
 - current amplitude 12 mA;
 - current offset 0 mA;
 - duration 100 ns;
 - pause 100 ns.
- 2) continuous spikes:
 - current 12 mA;
 - current offset 0 mA;
 - duration 400 ns;
 - pause 400 ns.
3)

- current amplitude 9 mA;
- current offset 3 mA;
- (i.e. maximum amplitude = 3 mA + 9 mA = 12 mA);

37

- duration 150 ns;
- pause 300 ns.
- 4) random spikes:
 - current amplitude 60 mA;
 - current offset 0 mA;
 - duration 200 ns;
 - pause between 0,1 ms and 500 ms, randomly varied.

5) random spikes:

- current amplitude 30 mA;
- current offset 0 mA;
- duration 400 ns;
- pause between 0,1 ms and 500 ms, randomly varied.

6) random spikes:

- current amplitude 57 mA;
- current offset 3 mA;
- (i.e. maximum amplitude = 3 mA + 57 mA = 60 mA);
- duration 200 ns;
- pause between 0,1 ms and 500 ms, randomly varied.

The specified spike durations shall be measured at 50 % of the spike amplitude.

5.2.2.4.6 Acceptance criteria

The voltage on contact C1 of the UICC-Terminal interface shall be within the ranges specified in the conformance requirements.

5.2.3 Electrical tests on contact C2

C2 = Reset (RST).

5.2.3.1 Electrical tests on contact C2: 3 V - 5 V

5.2.3.1.1 Definition and applicability

When the user equipment is activated, the voltage on contact C2 of the UICC-Terminal interface shall remain in the specified range in order to ensure correct operation and to prevent any damage to the UICC.

For applicability of this test case see clause 3.8.

5.2.3.1.2 Conformance requirement

- 1) The voltage on contact C2 (RST) of the UICC-Terminal interface shall be between -0,3 V and +0,6 V for a current of -200 μ A in low state and between Vcc -0,7 V and Vcc + 0,3 V for a current of +20 μ A in high state when the Terminal is in 5 V operation mode.
- 2) The voltage on contact C2 (RST) of the UICC-Terminal interface shall be between -0,3 V and $0,2 \times Vcc$ for a current of -200 μ A in low state and between $0,8 \times Vcc$ and Vcc + 0,3 V for a current of +20 μ A in high state when the Terminal is in 3 V operation mode.

5.2.3.1.3 Reference

- 1) ETSI TS 102 221 [1], clause 5.1.
- 2) ETSI TS 102 221 [1], clause 5.2.

5.2.3.1.4 Test purpose

To verify that the Terminal keeps the voltage on contact C2 (RST) of the UICC-Terminal interface within the specified range, as given in the conformance requirement.

5.2.3.1.5 Method of test

5.2.3.1.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The UE shall be activated.

The remaining contacts of the UICC-Terminal interface shall be held in nominal test conditions (see clause 5.2.1).

5.2.3.1.5.2 Procedure

The voltage on contact C2 (RST) of the UICC-Terminal interface shall be measured.

5.2.3.1.6 Acceptance criteria

The voltage on contact C2 (RST) of the UICC-Terminal interface shall be within the range specified in the conformance requirement.

5.2.3.2 Electrical tests on contact C2: 1,8 V - 3 V

5.2.3.2.1 Definition and applicability

When the user equipment is activated, the voltage on contact C2 of the UICC-Terminal interface shall remain in the specified range in order to ensure correct operation and to prevent any damage to the UICC.

For applicability of this test case see clause 3.8.

5.2.3.2.2 Conformance requirement

- 1) The voltage on contact C2 (RST) of the UICC-Terminal interface shall be between -0,3 V and $0,2 \times Vcc$ for a current of -200 μ A in low state and between $0,8 \times Vcc$ and Vcc + 0,3 V for a current of +20 μ A in high state when the Terminal is in 3 V operation mode.
- 2) The voltage on contact C2 (RST) of the UICC-Terminal interface shall be between -0,3 V and $0,2 \times Vcc$ for a current of -200 μ A in low state and between $0,8 \times Vcc$ and Vcc + 0,3 V for a current of +20 μ A in high state when the Terminal is in 1,8 V operation mode.

5.2.3.2.3 Reference

- 1) ETSI TS 102 221 [1], clause 5.2.
- 2) ETSI TS 102 221 [1], clause 5.3.

5.2.3.2.4 Test purpose

To verify that the Terminal keeps the voltage on contact C2 (RST) of the UICC-Terminal interface within the specified range, as given in the conformance requirement.

5.2.3.2.5 Method of test

5.2.3.2.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The UE shall be activated.

The remaining contacts of the UICC-Terminal interface shall be held in nominal test conditions (see clause 5.2.1).

5.2.3.2.5.2 Procedure

The voltage on contact C2 (RST) of the UICC-Terminal interface shall be measured.

5.2.3.2.6 Acceptance criteria

The voltage on contact C2 (RST) of the UICC-Terminal interface shall be within the range specified in the conformance requirement.

5.2.4 Electrical tests on contact C3

C3 = Clock (CLK).

5.2.4.1 Electrical tests on contact C3: 3 V - 5 V

5.2.4.1.1 Definition and applicability

When the user equipment is activated, the voltage, the rise/fall time of the signal, the clock cycle ratio and the frequency on contact C3 of the UICC - Terminal interface shall remain in the specified range in order to ensure correct operation and to prevent any damage to the UICC.

For applicability of this test case see clause 3.8.

5.2.4.1.2 Conformance requirement

- 1) The voltage on contact C3 (CLK) of the UICC Terminal interface shall be between -0,3 V and +0,5 V for a current of -200 μ A in low state and between 0,7 × Vcc and Vcc + 0,3 V for a current of +20 μ A in high state when the Terminal is in 5 V operation mode.
- 2) The rise and the fall time of the clock signal shall not exceed 9 % of the clock period with a maximum of 0,5 µs when the Terminal is in 5 V operation mode.
- 3) The cycle ratio of the clock signal shall be between 40 % and 60 % of the period, in steady state when the Terminal is in 5 V operation mode.
- 4) The frequency of the clock signal shall be between 1 MHz and 5 MHz when the Terminal is in 5 V operation mode.
- 5) The voltage on contact C3 (CLK) of the UICC Terminal interface shall be between -0,3 V and $0,2 \times Vcc$ for a current of -20 μ A in low state and between $0,7 \times Vcc$ and Vcc + 0,3 V for a current of +20 μ A in high state when the Terminal is in 3 V operation mode.
- 6) The rise and the fall time of the clock signal shall not exceed 50 ns when the Terminal is in 3 V operation mode.
- 7) The cycle ratio of the clock signal shall be between 40 % and 60 % of the period, in steady state when the Terminal is in 3 V operation mode.
- 8) The frequency of the clock signal shall be between 1 MHz and 5 MHz when the Terminal is in 3 V operation mode.

5.2.4.1.3 Reference

1 - 4) ETSI TS 102 221 [1], clause 5.1.

5 - 8) ETSI TS 102 221 [1], clause 5.2.

5.2.4.1.4 Test purpose

To verify that the Terminal keeps the voltage, the rise and fall time, the cycle ratio and the frequency on contact C3 (CLK) of the UICC - Terminal interface within the ranges specified in the conformance requirements.

40

5.2.4.1.5 Method of test

5.2.4.1.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The UE shall be activated.

The remaining contacts of the UICC-Terminal interface shall be held in nominal test conditions (see clause 5.2.1).

5.2.4.1.5.2 Procedure

The voltage, the rise/fall time, the clock cycle ratio and the frequency on contact C3 (CLK) of the UICC-Terminal interface shall be measured.

5.2.4.1.6 Acceptance criteria

The voltage, the rise and fall time, the cycle ratio and the frequency on contact C3 (CLK) of the UICC-Terminal interface shall be within the ranges specified in the conformance requirements.

5.2.4.2 Electrical tests on contact C3: 1,8 V - 3 V

5.2.4.2.1 Definition and applicability

When the user equipment is activated, the voltage, the rise/fall time of the signal, the clock cycle ratio and the frequency on contact C3 of the UICC - Terminal interface shall remain in the specified range in order to ensure correct operation and to prevent any damage to the UICC.

For applicability of this test case see clause 3.8.

5.2.4.2.2 Conformance requirement

- 1) The voltage on contact C3 (CLK) of the UICC Terminal interface shall be between -0,3 V and $0,2 \times Vcc$ for a current of -20 μ A in low state and between $0,7 \times Vcc$ and Vcc + 0,3 V for a current of +20 μ A in high state when the Terminal is in 3 V operation mode.
- 2) The rise and the fall time of the clock signal shall not exceed 50 ns when the Terminal is in 3 V operation mode.
- 3) The cycle ratio of the clock signal shall be between 40 % and 60 % of the period, in steady state when the Terminal is in 3 V operation mode.
- 4) The frequency of the clock signal shall be between 1 MHz and 5 MHz when the Terminal is in 3 V operation mode.
- 5) The voltage on contact C3 (CLK) of the UICC-Terminal interface shall be between -0,3 V and $0,2 \times Vcc$ for a current of -20 μ A in low state and between $0,7 \times Vcc$ and Vcc + 0,3 V for a current of +20 μ A in high state when the Terminal is in 1,8 V operation mode.
- 6) The rise and the fall time of the clock signal shall not exceed 50 ns when the Terminal is in 1,8 V operation mode.
- 7) The cycle ratio of the clock signal shall be between 40 % and 60 % of the period, in steady state when the Terminal is in 1,8 V operation mode.

8) The frequency of the clock signal shall be between 1 MHz and 5 MHz when the Terminal is in 1,8 V operation mode.

5.2.4.2.3 Reference

1 - 4) ETSI TS 102 221 [1], clause 5.2.

5 - 8) ETSI TS 102 221 [1], clause 5.3.

5.2.4.2.4 Test purpose

To verify that the Terminal keeps the voltage, the rise and fall time, the cycle ratio and the frequency on contact C3 (CLK) of the UICC - Terminal interface within the ranges specified in the conformance requirements.

5.2.4.2.5 Method of test

5.2.4.2.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The UE shall be activated.

The remaining contacts of the UICC-Terminal interface shall be held in nominal test conditions (see clause 5.2.1).

5.2.4.2.5.2 Procedure

The voltage, the rise/fall time, the clock cycle ratio and the frequency on contact C3 (CLK) of the UICC-Terminal interface shall be measured.

5.2.4.2.6 Acceptance criteria

The voltage, the rise and fall time, the cycle ratio and the frequency on contact C3 (CLK) of the UICC-Terminal interface shall be within the ranges specified in the conformance requirements.

5.2.5 Electrical tests on contact C7

C7 = Input - output (I/O).

5.2.5.1 Electrical tests on contact C7, Test 1: 3 V - 5 V

5.2.5.1.1 Definition and applicability

When the user equipment is activated, the Terminal shall keep the voltage, the current and the rise/fall time of the signal on contact C7 of the UICC-Terminal interface within the specified range in order to ensure correct operation and to prevent any damage to the UICC.

For applicability of this test case see clause 3.8.

5.2.5.1.2 Conformance requirement

- 1) Terminal receiving state A (low state):
 - With an imposed voltage of 0 V the current flowing out of the Terminal shall not exceed 1 mA when the Terminal is in 5 V operation mode.
- 2) Terminal transmitting state A (low state):
 - The voltage shall be between -0.3 V and $0.15 \times$ Vcc when a current of 1 mA flowing into the Terminal is applied when the Terminal is in 5 V operation mode.
- 3) Terminal transmitting or receiving state Z (high state):
 - The voltage shall be between +3,8 V (V_{OH})/0,7 × Vcc (V_{IH}) respectively and Vcc + 0,3 V when a current of 20 µA flowing out of the Terminal is applied when the Terminal is in 5 V operation mode.

- 4) The rise time and the fall time of the I/O signal shall not exceed 1 µs when the Terminal is in 5V operation mode.
- 5) Terminal receiving state A (low state):
 - With an imposed voltage of 0 V the current flowing out of the Terminal shall not exceed 1 mA when the Terminal is in 3 V operation mode.
- 6) Terminal transmitting state A (low state):
 - The voltage shall be between -0.3 V and $0.2 \times$ Vcc when a current of 1 mA flowing into the Terminal is applied when the Terminal is in 3 V operation mode.
- 7) Terminal transmitting or receiving state Z (high state):
 - The voltage shall be between $0.7 \times Vcc$ and Vcc + 0.3 V when a current of 20 μ A flowing out of the Terminal is applied when the Terminal is in 3 V operation mode.
- The rise time and the fall time of the I/O signal shall not exceed 1 μs when the Terminal is in 3 V operation mode.

5.2.5.1.3 Reference

1 - 4) ETSI TS 102 221 [1], clause 5.1.

5 - 8) ETSI TS 102 221 [1], clause 5.2.

5.2.5.1.4 Test purpose

To verify that the Terminal keeps the voltage, the current and the rise and fall times of the signal on contact C7 (I/O) of the UICC-Terminal interface within the ranges specified in the conformance requirements.

5.2.5.1.5 Method of test

5.2.5.1.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The UE shall be activated.

The remaining contacts of the UICC-Terminal interface shall be held in nominal test conditions (see clause 5.2.1).

5.2.5.1.5.2 Procedure

The voltage, the current and the rise/fall time on contact C7 (I/O) of the UICC-Terminal interface shall be measured.

5.2.5.1.6 Acceptance criteria

The voltage, the current and the rise and fall times of the signal on contact C7 (I/O) of the UICC-Terminal interface shall be within the ranges specified in the conformance requirements.

5.2.5.2 Electrical tests on contact C7, Test 2: 3 V - 5 V

5.2.5.2.1 Definition and applicability

When the user equipment is activated, the Terminal shall keep the voltage, the current and the rise/fall time of the signal on contact C7 of the UICC-Terminal interface within the specified range in order to ensure correct operation and to prevent any damage to the UICC.

For applicability of this test case see clause 3.8.

5.2.5.2.2 Conformance requirement

- 1) Terminal receiving state A (low state):
 - With an imposed voltage of 0 V the current flowing out of the Terminal shall not exceed 1 mA when the Terminal is in 5 V operation mode.

- 2) Terminal transmitting state A (low state):
 - The voltage shall be between -0.3 V and $0.15 \times$ Vcc when a current of 1 mA flowing into the Terminal is applied when the Terminal is in 5 V operation mode.
- 3) Terminal transmitting or receiving state Z (high state):
 - The voltage shall be between +3,8 V (V_{OH})/0,7 × Vcc (V_{IH}) respectively and Vcc + 0,3 V when a current of 20 µA flowing out of the Terminal is applied when the Terminal is in 5 V operation mode.
- 4) The rise time and the fall time of the I/O signal shall not exceed 100 ns when the Terminal is in 5V operation mode.
- 5) Terminal receiving state A (low state):
 - With an imposed voltage of 0 V the current flowing out of the Terminal shall not exceed 1 mA when the Terminal is in 3 V operation mode.
- 6) Terminal transmitting state A (low state):
 - The voltage shall be between -0.3 V and $0.2 \times$ Vcc when a current of 1 mA flowing into the Terminal is applied when the Terminal is in 3 V operation mode.
- 7) Terminal transmitting or receiving state Z (high state):
 - The voltage shall be between $0.7 \times Vcc$ and Vcc + 0.3 V when a current of 20 μ A flowing out of the Terminal is applied when the Terminal is in 3 V operation mode.
- 8) When the low impedance buffer is selected, the rise time and the fall time of the I/O signal shall not exceed 100 ns when the Terminal is in 3 V operation mode.

5.2.5.2.3 Reference

1 - 4) ETSI TS 102 221 [1], clause 5.1.

5 - 8) ETSI TS 102 221 [1], clause 5.2.

5.2.5.2.4 Test purpose

To verify that the Terminal supporting low impedance buffer keeps the voltage, the current and the rise and fall times of the signal on contact C7 (I/O) of the UICC-Terminal interface within the ranges specified in the conformance requirements.

5.2.5.2.5 Method of test

5.2.5.2.5.1 Initial condition

The Terminal shall be connected to a UICC simulator.

The UE shall be activated.

The remaining contacts of the UICC-Terminal interface shall be held in nominal test conditions (see clause 5.2.1).

An ATR indicating the support of the low impedance buffer shall have been received and the PPS procedure selecting the low impedance buffer shall have been successfully completed.

5.2.5.2.5.2 Procedure

The voltage, the current and the rise/fall time on contact C7 (I/O) of the UICC-Terminal interface shall be measured.

5.2.5.2.6 Acceptance criteria

The voltage, the current and the rise and fall times of the signal on contact C7 (I/O) of the UICC-Terminal interface shall be within the ranges specified in the conformance requirements.

5.2.5.3 Electrical tests on contact C7, Test 1: 1,8 V - 3 V

5.2.5.3.1 Definition and applicability

When the user equipment is activated, the Terminal shall keep the voltage, the current and the rise/fall time of the signal on contact C7 of the UICC-Terminal interface within the specified range in order to ensure correct operation and to prevent any damage to the UICC.

For applicability of this test case see clause 3.8.

5.2.5.3.2 Conformance requirement

- 1) Terminal receiving state A (low state):
 - With an imposed voltage of 0 V the current flowing out of the Terminal shall not exceed 1 mA when the Terminal is in 3 V operation mode.
- 2) Terminal transmitting state A (low state):
 - The voltage shall be between -0,3 V and $0,2 \times Vcc$ when a current of 1 mA flowing into the Terminal is applied when the Terminal is in 3 V operation mode.
- 3) Terminal transmitting or receiving state Z (high state):
 - The voltage shall be between $0.7 \times Vcc$ and Vcc + 0.3 V when a current of 20 μ A flowing out of the Terminal is applied when the Terminal is in 3 V operation mode.
- 4) The rise time and the fall time of the I/O signal shall not exceed 1 µs when the Terminal is in 3 V operation mode.
- 5) Terminal receiving state A (low state):
 - With an imposed voltage of 0 V the current flowing out of the Terminal shall not exceed 1 mA when the Terminal is in 1,8 V operation mode.
- 6) Terminal transmitting state A (low state):
 - The voltage shall be between -0,3 V and $0,2 \times Vcc$ when a current of 1 mA flowing into the Terminal is applied when the Terminal is in 1,8 V operation mode.
- 7) Terminal transmitting or receiving state Z (high state):
 - The voltage shall be between $0.7 \times Vcc$ and Vcc + 0.3 V when a current of 20 μ A flowing out of the Terminal is applied when the Terminal is in 1.8 V operation mode.
- 8) The rise time and the fall time of the I/O signal shall not exceed 1 μs when the Terminal is in 1,8 V operation mode.

5.2.5.3.3 Reference

1 - 4) ETSI TS 102 221 [1], clause 5.2.

4 - 8) ETSI TS 102 221 [1], clause 5.3.

5.2.5.3.4 Test purpose

To verify that the Terminal keeps the voltage, the current and the rise and fall times of the signal on contact C7 (I/O) of the UICC-Terminal interface within the ranges specified in the conformance requirements.

5.2.5.3.5 Method of test

5.2.5.3.5.1 Initial condition

The Terminal shall be connected to an UICC simulator.

The UE shall be activated.

The remaining contacts of the UICC-Terminal interface shall be held in nominal test conditions (see clause 5.2.1).

5.2.5.3.5.2 Procedure

The voltage, the current and the rise/fall time on contact C7 (I/O) of the UICC-Terminal interface shall be measured.

5.2.5.3.6 Acceptance criteria

The voltage, the current and the rise and fall times of the signal on contact C7 (I/O) of the UICC-Terminal interface shall be within the ranges specified in the conformance requirements.

5.2.5.4 Electrical tests on contact C7, Test 2: 1,8 V - 3 V

5.2.5.4.1 Definition and applicability

When the user equipment is activated, the Terminal shall keep the voltage, the current and the rise/fall time of the signal on contact C7 of the UICC-Terminal interface within the specified range in order to ensure correct operation and to prevent any damage to the UICC.

For applicability of this test case see clause 3.8.

5.2.5.4.2 Conformance requirement

- 1) Terminal receiving state A (low state):
 - With an imposed voltage of 0 V the current flowing out of the Terminal shall not exceed 1 mA when the Terminal is in 3 V operation mode.
- 2) Terminal transmitting state A (low state):
 - The voltage shall be between -0,3 V and $0,2 \times Vcc$ when a current of 1 mA flowing into the Terminal is applied when the Terminal is in 3 V operation mode.
- 3) Terminal transmitting or receiving state Z (high state):
 - The voltage shall be between $0.7 \times Vcc$ and Vcc + 0.3 V when a current of 20 μ A flowing out of the Terminal is applied when the Terminal is in 3 V operation mode.
- 4) The rise time and the fall time of the I/O signal shall not exceed 100 ns when the Terminal is in 3 V operation mode.
- 5) Terminal receiving state A (low state):
 - With an imposed voltage of 0 V the current flowing out of the Terminal shall not exceed 1 mA when the Terminal is in 1,8 V operation mode.
- 6) Terminal transmitting state A (low state):
 - The voltage shall be between -0,3 V and $0,2 \times$ Vcc when a current of 1 mA flowing into the Terminal is applied when the Terminal is in 1,8 V operation mode.
- 7) Terminal transmitting or receiving state Z (high state):
 - The voltage shall be between $0.7 \times Vcc$ and Vcc + 0.3 V when a current of 20 μ A flowing out of the Terminal is applied when the Terminal is in 1.8 V operation mode.
- 8) When the low impedance buffer is selected, the rise time and the fall time of the I/O signal shall not exceed 100 ns when the Terminal is in 1,8 V operation mode.

5.2.5.4.3 Reference

1 - 4) ETSI TS 102 221 [1], clause 5.2.

4 - 8) ETSI TS 102 221 [1], clause 5.3.

5.2.5.4.4 Test purpose

To verify that the Terminal supporting low impedance buffer keeps the voltage, the current and the rise and fall times of the signal on contact C7 (I/O) of the UICC-Terminal interface within the ranges specified in the conformance requirements.

5.2.5.4.5 Method of test

5.2.5.4.5.1 Initial condition

The Terminal shall be connected to a UICC simulator.

The UE shall be activated.

The remaining contacts of the UICC-Terminal interface shall be held in nominal test conditions (see clause 5.2.1).

An ATR indicating the support of the low impedance buffer shall have been received and the PPS procedure selecting the low impedance buffer shall have been successfully completed.

5.2.5.4.5.2 Procedure

The voltage, the current and the rise/fall time on contact C7 (I/O) of the UICC-Terminal interface shall be measured.

5.2.5.4.6 Acceptance criteria

The voltage, the current and the rise and fall times of the signal on contact C7 (I/O) of the UICC-Terminal interface shall be within the ranges specified in the conformance requirements.

6 Initial communication tests

6.1 ATR

6.1.1 ATR characters

6.1.1.1 Definition and applicability

The ATR is the first string of bytes sent from the UICC to the Terminal after a reset has been performed.

The historical bytes indicate to the external world how to use the card.

Both protocols T=0 and T=1 are mandatory for the Terminal. The protocol starts after either the answer to reset or a successful PPS exchange.

For applicability of this test case see clause 3.8.

6.1.1.2 Conformance requirement

- 1) The Terminal shall adopt the data encoding convention and initial etu time defined in the initial character TS of the ATR.
- 2) The Terminal shall be able to receive interface characters for transmission protocols other than T=0 and T=1, historical bytes and a check byte, even if only T=0 and T=1 are used by the Terminal.

6.1.1.2.1 Reference

ETSI TS 102 221 [1], clauses 6.3 and 7.

6.1.1.3 Test purpose

- 1) To verify that the Terminal adopts the data encoding convention and initial etu time defined in the initial character TS of the ATR.
- 2) To verify that the Terminal accepts interface characters for transmission protocols (T=0 and T=1), historical bytes and a check byte.

6.1.1.4 Method of test

6.1.1.4.1 Initial conditions

The Terminal shall be connected to the UICC (or UICC simulator).

6.1.1.4.2 Procedure

- a) The Terminal shall be powered on.
- b) The UICC (or UICC simulator) shall send an ATR as follows:

Character	Value	Description	
TS	'3B'	Indicates direct convention	
T0	'97'	TA1 and TD1 are present	
		7 bytes of historical bytes	
TA1	'11'	Clock rate conversion factor FI=1 (F=372)	
		Baud rate adjustment factor DI=1 (D=1)	
TD1	'80'	TD2 only is present	
		Protocol T=0 supported by UICC	
TD2	'1F'	TA3 only is present	
		Global interface bytes following (T=15)	
TA3	'46'	Clock stop supported (low electrical state)	
		1,8 V technology UICC	
T1	'80'		
T2	'31'	Card data services	
T3	'A0'	SELECT by AID supported	
		EFDIR present	
T4	'73'	Card capabilities	
T5	'BE'	SFI supported	
T6	'21'	Data Coding Byte	
T7	'00'	No extended Lc and Le	
		No Logical channels supported	
TCK	'A2'	Check byte	

- c) The Terminal shall be made to send further commands to the UICC (or UICC simulator) (e.g. by entering the PIN).
- d) The Terminal is switched off and on.
- e) The UICC (or UICC simulator) shall send an ATR as follows:

Character	Value	Description	
TS	'3F'	Indicates inverse convention	
T0	'97'	TA1 and TD1 are present	
		7 bytes of historical bytes	
TA1	'11'	Clock rate conversion factor FI=1 (F=372)	
		Baud rate adjustment factor DI=1 (D=1)	
TD1	'80'	TD2 only is present	
		Protocol T=0 supported by UICC	
TD2	'1F'	TA3 only is present	
		Global interface bytes following (T=15)	
TA3	'46'	Clock stop supported (low electrical state)	
		1,8 V technology UICC	
T1	'80'		
T2	'31'	Card data services	
T3	'A0'	SELECT by AID supported	
		EFDIR present	
T4	'73'	Card capabilities	
T5	'BE'	SFI supported	
Т6	'21'	Data Coding Byte	
T7	'00'	No extended Lc and Le	
		No Logical channels supported	
TCK	'A2'	Check byte	

- f) The Terminal shall be made to send further commands to the UICC (or UICC simulator) (e.g. by entering the PIN).
- g) The Terminal is switched off and on.
- h) The UICC (or UICC simulator) shall send an ATR as follows:

Character	Value	Description	
TS	'3F'	Indicates inverse convention	
T0	'97'	TA1, and TD1 are present	
		7 bytes of historical bytes	
TA1	'11'	Clock rate conversion factor FI=1 (F=372)	
		Baud rate adjustment factor DI=1 (D=1)	
TD1	'80'	Only TD2 is present	
		Protocol T=0 supported by UICC	
TD2	'B1'	TA3, TB3 and TD3 are present	
		Protocol T=1 supported by UICC	
TA3	'FE'	IFSC is 254 bytes long	
TB3	'00'	Block Waiting Integer=0	
		Character Waiting Integer=0	
TD3	'1F'	Only TA4 is present	
		Global interface bytes following (T=15)	
TA4	'46'	Clock stop supported (low electrical state)	
		1,8 V technology UICC	
T1	'80'		
T2	'31'	Card data services	
T3	'A0'	SELECT by AID supported	
		EFDIR present	
T4	'73'	Card capabilities	
T5	'BE'	SFI supported	
T6	'21'	Data Coding Byte	
T7	'00'	No extended Lc and Le	
		No Logical channels supported	
TCK	'ED'	Check byte	

- i) The Terminal shall be made to send further commands to the UICC (or UICC simulator) (e.g. by entering the PIN).
- j) The Terminal is switched off and on.
- k) The UICC (or UICC simulator) shall send an ATR as follows:

Character	Value	Description	
TS	'3B'	Indicates direct convention	
T0	'97'	TA1, and TD1 are present	
		7 bytes of historical bytes	
TA1	'11'	Clock rate conversion factor FI=1 (F=372)	
		Baud rate adjustment factor DI=1 (D=1)	
TD1	'91'	TA2 and TD2 are present	
		Protocol T=1 supported by UICC	
TA2	'81'	Protocol T=1 used in specific mode	
		Parameters indicated by the interface bytes, and card is not	
		able to change mode	
TD2	'B1'	TA3, TB3 and TD3 are present	
		Protocol T=1 supported by UICC	
TA3	'FE'	IFSC is 254 bytes long	
TB3	'00'	Block Waiting Integer=0	
		Character Waiting Integer=0	
TD3	'0F'	Global interface bytes following (T=15)	
TA4	'46'	Clock stop supported (low electrical state)	
		1,8 V technology UICC	
T1	'80'		
T2	'31'	Card data services	

Character	Value	Description	
T3	'A0'	SELECT by AID supported EF _{DIR} present	
T4	'73'	Card capabilities	
T5	'BE'	SFI supported	
T6	'21'	Data Coding Byte	
T7	'00'	No extended Lc and Le No Logical channels supported	
TCK	'7D'	Check byte	

- 1) The Terminal shall be made to send further commands to the UICC (or UICC simulator) (e.g. by entering the PIN).
- m) The Terminal is switched off and on.
- n) The UICC (or UICC simulator) shall send an ATR as follows:

Character	Value	Description	
TS	'3F'	Indicates inverse convention	
T0	'97'	TA1, and TD1 are present	
		7 bytes of historical bytes	
TA1	'11'	Clock rate conversion factor FI=1 (F=372)	
		Baud rate adjustment factor DI=1 (D=1)	
TD1	'91'	TA2 and TD2 are present	
		Protocol T=1 supported by UICC	
TA2	'81'	Protocol T=1 used in specific mode	
		Parameters indicated by the interface bytes, and card is not	
		able to change mode	
TD2	'B1'	TA3, TB3 and TD3 are present	
		Protocol T=1 supported by UICC	
TA3	'FE'	IFSC is 254 bytes long	
TB3	'00'	Block Waiting Integer=0	
		Character Waiting Integer=0	
TD3	'0F'	Global interface bytes following (T=15)	
TA4	'46'	Clock stop supported (low electrical state)	
		1,8 V technology UICC	
T1	'80'		
T2	'31'	Card data services	
Т3	'A0'	SELECT by AID supported	
		EF _{DIR} present	
T4	'73'	Card capabilities	
T5	'BE'	SFI supported	
Т6	'21'	Data Coding Byte	
T7	'00'	No extended Lc and Le	
		No Logical channels supported	
TCK	'7D'	Check byte	

o) The Terminal shall be made to send further commands to the UICC (or UICC simulator) (e.g. by entering the PIN).

6.1.1.5 Acceptance criteria

In step c), the Terminal shall start a T=0 session in direct convention and work with the UICC (or UICC simulator).

In steps f) and i), the Terminal shall start a T=0 session in inverse convention and work with the UICC (or UICC simulator).

In step 1), the Terminal shall start a T=1 session in direct convention and work with the UICC (or UICC simulator).

In step o), the Terminal shall start a T=1 session in inverse convention and work with the UICC (or UICC simulator).

6.2 Clock stop mode with 1,8 V technology UICC

6.2.1 Definition and applicability

The Terminal shall be able to receive interface characters, historical bytes and a check byte, even if only T=0 and T=1 are used by the Terminal.

T=15 global interface parameters shall be returned by the UICC.

The UICC shall support the clock stop procedure. The clock stop mode is indicated in TA_i (i > 2) in T=15 in the ATR.

For applicability of this test case see clause 3.8.

6.2.2 Conformance requirement

If the UICC supports any other operating conditions even together with class A, clock stop mode shall be supported and the indication shall be set accordingly. The terminal shall follow this indication independently of operating conditions indicated by the card.

In case the UICC does not support any supply voltage indication, the UICC shall be treated as a 5 V only card by the Terminal.

The Terminal shall wait at least 1 860 clock cycles after having received the last character, including the guard time (2 etu), of the response before it switches off the clock. It shall wait at least 744 clock cycles before it sends the first command after having started the clock.

6.2.2.1 Reference

ETSI TS 102 221 [1], clauses 6.7, 6.10 and 11.1.1.4.6.1.

ISO/IEC 7816-3 [2], clauses 5.3.4 and 6.5.5.

6.2.3 Test purpose

- 1) To verify that the clock is only switched off as indicated in the ATR first global interface byte and file characteristics (byte 1 of the directory characteristics).
- 2) To verify that the timing of the clock switching is as specified.

6.2.4 Method of test

6.2.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator. PIN shall be enabled.

6.2.4.2 Procedure

a) The Terminal shall be powered on and the UICC simulator shall send an ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct convention
Т0	'97'	TA1 and TD1 are present
		7 bytes of historical bytes
TA1	'11'	Clock rate conversion factor FI=1 (F=372)
		Baud rate adjustment factor DI=1 (D=1)
TD1	'80'	TD2 only is present
		Protocol T=0 supported by UICC
TD2	'1F'	TA3 only is present
		Global interface bytes following (T=15)
TA3	'C6'	Clock stop supported (no preferred state)
		1,8 V technology UICC
T1	'80'	
T2	'31'	Card data services

Character	Value	Description	
T3	'A0'	SELECT by AID supported	
		EFDIR present	
T4	'73'	Card capabilities	
T5	'BE'	SFI supported	
T6	'21'	Data Coding Byte	
T7	'00'	No extended Lc and Le	
		No Logical channels supported	
TCK	'22'	Check byte	

and be used with bits set as follows:

I	b8	b7	b6	b5	B4	b3	b2	b1	Meaning
Ī	0	1	1	0	0	0	0	1	Voltage classes BC and clock stop
									mode supported. No preferred level.

b) When the Terminal is in mode PIN check, 10 s shall elapse before the PIN shall be entered.

c) The Terminal shall be powered off and on. The UICC simulator shall send an ATR as follows:

Character	Value	Description		
TS	'3B'	Indicates direct convention		
T0	'97'	TA1 and TD1 are present		
		7 bytes of historical bytes		
TA1	'11'	Clock rate conversion factor FI = 1 (F = 372)		
		Baud rate adjustment factor $DI = 1$ ($D = 1$)		
TD1	'80'	TD2 only is present		
		Protocol T=0 supported by UICC		
TD2	'1F'	TA3 only is present		
		Global interface bytes following (T=15)		
TA3	'86'	Clock stop supported (high electrical state)		
		1,8 V technology UICC		
T1	'80'			
T2	'31'	Card data services		
Т3	'A0'	SELECT by AID supported		
		EFDIR present		
T4	'73'	Card capabilities		
T5	'BE'	SFI supported		
Т6	'21'	Data Coding Byte		
T7	'00'	No extended Lc and Le		
		No Logical channels supported		
TCK	'62'	Check byte		

and be used with bits set as follows:

b8	b7	b6	b5	b4	b3	b2	b1	Meaning
0	1	1	0	0	1	0		Voltage classes BC and clock stop mode supported. High level preferred

d) When the Terminal is in mode PIN check, 10 s shall elapse before the PIN shall be entered.

e) The Terminal shall be powered off and on. The UICC simulator shall send an ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct convention
T0	'97'	TA1 and TD1 are present
		7 bytes of historical bytes
TA1	'11'	Clock rate conversion factor FI=1 (F=372)
		Baud rate adjustment factor DI=1 (D=1)
TD1	'80'	TD2 only is present
		Protocol T=0 supported by UICC

Character	Value	Description
TD2	'1F'	TA3 only is present
		Global interface bytes following (T=15)
TA3	'46'	Clock stop supported (low electrical state)
		1,8 V technology UICC
T1	'80'	
T2	'31'	Card data services
T3	'A0'	SELECT by AID supported
		EFDIR present
T4	'73'	Card capabilities
T5	'BE'	SFI supported
T6	'21'	Data Coding Byte
T7	'00'	No extended Lc and Le
		No Logical channels supported
TCK	'A2'	Check byte

and be used with bits set as follows:

k	b8	b7	b6	b5	b4	b3	b2	b1	Meaning
	0	1	1	0	1	0	0		Voltage classes BC and clock stop mode supported. Low level preferred

f) When the Terminal is in mode PIN check, 10 s shall elapse before the PIN shall be entered.

6.2.5 Acceptance criteria

- 1) During step b), the Terminal shall switch off the clock at either high or low level.
- 2) During step d), the Terminal shall switch off the clock at high level.
- 3) During step f), the Terminal shall switch off the clock at low level.
- 4) During steps b), d) and f), the Terminal shall not switch off the clock until at least 1 860 clock cycles after having received the last character of the response including the minimum guard time (2 etu).
- 5) During steps b), d) and f), the Terminal shall wait at least 744 clock cycles before it sends the first command after having restarted the clock.
- NOTE: The Terminal will operate at either 1,8 V or 3 V and use the supply voltage procedure if it does not support the first value.

6.3 Clock stop mode with 3 V technology UICC

6.3.1 Definition and applicability

The Terminal shall be able to receive interface characters, historical bytes and a check byte, even if only T=0 and T=1 are used by the Terminal.

T=15 global interface parameters shall be returned by the UICC.

The UICC shall support the clock stop procedure. The clock stop mode is indicated in TA_i (i > 2) in T=15 in the ATR.

For applicability of this test case see clause 3.8.

6.3.2 Conformance requirement

If the UICC supports any other operating conditions even together with class A, clock stop mode shall be supported and the indication shall be set accordingly. The terminal shall follow this indication independently of operating conditions indicated by the card.

In case the UICC does not support any supply voltage indication, the UICC shall be treated as a 5 V only card by the Terminal.

The Terminal shall wait at least 1 860 clock cycles after having received the last character, including the guard time (2 etu), of the response before it switches off the clock. It shall wait at least 744 clock cycles before it sends the first command after having started the clock.

6.3.2.1 Reference

ETSI TS 102 221 [1], clauses 6.7, 6.10 and 11.1.1.4.6.1.

ISO/IEC 7816-3 [2], clauses 5.3.4 and 6.5.5.

6.3.3 Test purpose

- 1) To verify that the clock is only switched off as indicated in the ATR first global interface byte and file characteristics (byte 1 of the directory characteristics).
- 2) To verify that the timing of the clock switching is as specified.

6.3.4 Method of test

6.3.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator. PIN shall be enabled.

6.3.4.2 Procedure

a) The Terminal shall be powered on and the UICC simulator shall send an ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct convention
T0	'97'	TA1 and TD1 are present
		7 bytes of historical bytes
TA1	'11'	Clock rate conversion factor FI=1 (F=372)
		Baud rate adjustment factor DI=1 (D=1)
TD1	'80'	TD2 only is present
		Protocol T=0 supported by UICC
TD2	'1F'	TA3 only is present
		Global interface bytes following (T=15)
TA3	'C3'	Clock stop supported (no preferred state)
		3 V technology UICC
T1	'80'	
T2	'31'	Card data services
T3	'A0'	SELECT by AID supported
		EFDIR present
T4	'73'	Card capabilities
T5	'BE'	SFI supported
T6	'21'	Data Coding Byte
T7	'00'	No extended Lc and Le
		No Logical channels supported
TCK	'27'	Check byte

and be used with bits set as follows:

b8	b7	b6	b5	B4	b3	b2	b1	Meaning
0	0	1	1	0	0	0	1	Voltage classes AB and clock stop
								mode supported. No preferred level

- b) When the Terminal is in mode PIN check, 10 s shall elapse before the PIN shall be entered.
- c) The Terminal shall be powered off and on. The UICC simulator shall send an ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct convention
T0	'97'	TA1 and TD1 are present

Character	Value	Description
		7 bytes of historical bytes
TA1	'11'	Clock rate conversion factor FI=1 (F=372)
		Baud rate adjustment factor DI=1 (D=1)
TD1	'80'	TD2 only is present
		Protocol T=0 supported by UICC
TD2	'1F'	TA3 only is present
		Global interface bytes following (T=15)
TA3	'83'	Clock stop supported (high electrical state)
		3 V technology UICC
T1	'80'	
T2	'31'	Card data services
Т3	'A0'	SELECT by AID supported
		EFDIR present
T4	'73'	Card capabilities
T5	'BE'	SFI supported
Т6	'21'	Data Coding Byte
T7	'00'	No extended Lc and Le
		No Logical channels supported
TCK	'67'	Check byte

and be used with bits set as follows:

b8	b7	b6	b5	b4	b3	b2	b1	Meaning
0	0	1	1	0	1	0		Voltage classes AB and clock stop mode supported. High level preferred

d) When the Terminal is in mode PIN check, 10 s shall elapse before the PIN shall be entered.

e) The Terminal shall be powered off and on. The UICC simulator shall send an ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct convention
T0	'97'	TA1 and TD1 are present
		7 bytes of historical bytes
TA1	'11'	Clock rate conversion factor FI=1 (F=372)
		Baud rate adjustment factor DI=1 (D=1)
TD1	'80'	TD2 only is present
		Protocol T=0 supported by UICC
TD2	'1F'	TA3 only is present
		Global interface bytes following (T=15)
TA3	'43'	Clock stop supported (low electrical state)
		3 V technology UICC
T1	'80'	
T2	'31'	Card data services
T3	'A0'	SELECT by AID supported
		EFDIR present
T4	'73'	Card capabilities
T5	'BE'	SFI supported
Т6	'21'	Data Coding Byte
T7	'00'	No extended Lc and Le
		No Logical channels supported
TCK	'A7'	Check byte

and be used with bits set as follows:

b8	b7	b6	b5	b4	b3	b2	b1	Meaning
0	0	1	1	1	0	0		Voltage classes AB and clock stop mode supported. Low level preferred

f) When the Terminal is in mode PIN check, 10 s shall elapse before the PIN shall be entered.

6.3.5 Acceptance criteria

- 1) During step b), the Terminal shall switch off the clock at either high or low level.
- 2) During step d), the Terminal shall switch off the clock at high level.
- 3) During step f), the Terminal shall switch off the clock at low level.
- 4) During steps b), d) and f), the Terminal shall operate at 3 V and not switch off the clock until at least 1 860 clock cycles after having received the last character of the response including the minimum guard time (2 etu).
- 5) During steps b), d) and f), the Terminal shall wait at least 744 clock cycles before it sends the first command after having restarted the clock.

6.4 Void

6.5 Speed enhancement

6.5.1 Definition and applicability

The Terminal shall at least support speed enhancement using (F,D) = (512,8) and (512,16) in addition to (372,1), the default.

For applicability of this test case see clause 3.8.

6.5.2 Conformance requirement

For the Terminal, it is mandatory to support F = 512 and D = 8 as well as F = 512 and D = 16 (in addition to the default values F = 372 and D = 1).

6.5.3 Test purpose

To verify that the Terminal supports the transmission parameters F = 512 and D = 8 as well as F = 512 and D = 16.

6.5.4 Method of test

6.5.4.1 Initial conditions

The Terminal is connected to the UICC simulator.

6.5.4.2 Procedure

- a) The Terminal is powered on.
- b) The UICC simulator sends an ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct convention
Т0	'97'	TA1, TD1 are present
		7 bytes of historical bytes
TA1	'94'	F=512, D=8
TD1	'80'	TD2 only is present
		T=0
TD2	'1F'	TA3 only is present
		Global interface bytes following
TA3	'46'	Clock stop supported (low electrical state)
		1,8 V technology UICC, supporting class B and class C
T1	'80'	
T2	'31'	Card data services
T3	'A0'	SELECT by AID supported
		EFDIR present

Character	Value	Description	
T4	'73'	Card capabilities	
T5	'BE'	SFI supported	
T6	'21'	Data Coding Byte	
T7	'00'	No extended Lc and Le	
		No Logical channels supported	
TCK	'27'	Check byte	

- c) After receipt of the PPS Request, the UICC simulator answers with the PPS Response "FF 10 94 7B" using a work waiting time of 9 600 etu (initial waiting time).
- d) The UICC simulator transmits with enhanced speed (F = 512, D = 8).
- e) The Terminal is switched off and on. The UICC simulator sends an ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct convention
Т0	'97'	TA1, TD1 are present
		7 bytes of historical bytes
TA1	'95'	F=512, D=16
TD1	'80'	TD2 only is present
		T=0
TD2	'1F'	TA3 only is present
		Global interface bytes following
TA3	'46'	Clock stop supported (low electrical state)
		1,8 V technology UICC, supporting class B and class C
T1	'80'	
T2	'31'	Card data services
Т3	'A0'	SELECT by AID supported
		EFDIR present
T4	'73'	Card capabilities
T5	'BE'	SFI supported
T6	'21'	Data Coding Byte
T7	'00'	No extended Lc and Le
		No Logical channels supported
TCK	'26'	Check byte

- f) After receipt of the PPS Request, the UICC simulator answers with the PPS Response "FF 10 95 7B" using a work waiting time of 9 600 etu (initial waiting time).
- g) The UICC simulator transmits with enhanced speed (F = 512, D = 16).

6.5.5 Acceptance criteria

After step b) the Terminal shall send to the UICC simulator the PPS Request "FF 10 94 7B".

After step c) the Terminal shall work with the UICC simulator.

After step e) the Terminal shall send to the UICC simulator the PPS Request "FF 10 95 7B".

After step f) the Terminal shall work with the UICC simulator.

7 Transmission protocol tests

The following tests apply to Terminals using either ID-1 or Plug-in UICC.

7.1 Character transmission

7.1.1 Bit/character duration during the transmission from the Terminal to the UICC

7.1.1.1 Definition and applicability

A character consists of 10 consecutive bits:

- 1 start bit in state L;
- 8 bits, which comprise the data byte;
- 1 even parity checking bit.

For applicability of this test case see clause 3.8.

7.1.1.2 Conformance requirement

The bit/character duration and the delay between two consecutive characters (between start leading edges) sent by the Terminal shall be in the range specified.

7.1.1.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.1.

7.1.1.3 Test purpose

To verify the timing during the transmission from the Terminal to the UICC.

7.1.1.4 Method of test

7.1.1.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

7.1.1.4.2 Procedure

A number of characters are transmitted from the Terminal to the UICC simulator. The UICC simulator shall measure the bit/character duration and the delay between two consecutive characters for all characters transmitted by the Terminal.

7.1.1.5 Acceptance criteria

The timing shall be in the specified range.

7.1.2 Bit/character duration during the transmission from the UICC to the Terminal

7.1.2.1 Definition and applicability

A character consists of 10 consecutive bits:

- 1 start bit in state L;
- 8 bits, which comprise the data byte;
- 1 even parity checking bit.

For applicability of this test case see clause 3.8.

7.1.2.2 Conformance requirement

The bit/character duration and the delay between two consecutive characters (between start leading edges) sent by the Terminal shall be in the range specified.

7.1.2.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.1.

7.1.2.3 Test purpose

To verify the timing during the transmission from the UICC to the Terminal.

7.1.2.4 Method of test

7.1.2.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

7.1.2.4.2 Procedure

The UICC simulator shall send responses with the maximum and minimum bit/character duration specified in ETSI TS 102 221 [1].

7.1.2.5 Acceptance criteria

The Terminal shall accept the response and act accordingly.

7.2 T=0 protocol

7.2.1 Timing

7.2.1.1 Definition and applicability

The minimum interval between the leading edge of the start bits of two consecutive characters shall be at least 12 etu. The Work Waiting Time (WWT) is the maximum interval between the start leading edge of any character sent by the UICC and the start leading edge of the previous character sent by either by the UICC or the terminal.

The value of the WWT shall not exceed $960 \times WI \times Fi/f$. WI is an integer received in the specific interface byte TC2. The clock rate conversion factor, Fi, may be indicated in TA1.

For applicability of this test case see clause 3.8.

7.2.1.2 Conformance requirement

- 1) If TA1 is absent the Terminal shall use the default value Fi = 372.
- 2) If no TC2 is available the Terminal shall use the default value of WI (10).
- 3) The Terminal shall accept characters sent by the UICC with the Work Waiting Time within the specified range.

7.2.1.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.2.1.

7.2.1.3 Test purpose

- 1) To verify the correct evaluation of the characters TA1 and TC2 indicated in the ATR.
- 2) To verify that the Terminal accepts the minimum and maximum Work Waiting Time during the transmission from the UICC to the Terminal.

3) To verify that the Terminal deactivates the UICC if WWT is exceeded.

7.2.1.4 Method of test

7.2.1.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

7.2.1.4.2 Procedure

a) Upon reception of a reset the UICC simulator shall transmit the ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct or inverse convention
T0	'87'	TD1 only is present
		7 bytes of historical bytes
TD1	'80'	TD2 only is present
TD2	'1F'	TA3 only is present
		Global interface bytes following
TA3	'46'	Clock stop supported (low electrical state)
		1,8 V technology UICC
T1	'80'	
T2	'31'	Card data services
T3	'A0'	SELECT by AID supported
		EFDIR present
T4	'73'	Card capabilities
T5	'BE'	SFI supported
T6	'21'	Data Coding Byte
Τ7	'00'	No extended Lc and Le
		No Logical channels supported
TCK	'A3'	Check byte

b) Upon reception of a reset the UICC simulator shall transmit the ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct or inverse convention
Т0	'97'	TA1 and TD1 are present
		7 bytes of historical bytes
TA1	'11'	Clock rate conversion factor FI=1 (F=372)
		Baud rate adjustment factor DI=1 (D=1)
TD1	'C0'	TC2 and TD2 are present
TC2	'01'	WI=1 meaning WWT=960x(Fi/f)x1
TD2	'1F'	TA3 only is present
		Global interface bytes following
TA3	'46'	Clock stop supported (low electrical state)
		1,8 V technology UICC
T1	'80'	
T2	'31'	Card data services
Т3	'A0'	SELECT by AID supported
		EFDIR present
T4	'73'	Card capabilities
T5	'BE'	SFI supported
T6	'21'	Data Coding Byte
T7	'00'	No extended Lc and Le
		No Logical channels supported
TCK	'E3'	Check byte

- c-1) The UICC simulator shall transmit with a WWT of 12 etu.
- c-2) The UICC simulator shall transmit with the specified WWT (960 \times (Fi/f) \times WI).
- c-3) The UICC simulator shall not transmit i.e. WWT exceeded.

7.2.1.5 Acceptance criteria

In step a), the Terminal shall work with the UICC simulator using the default values of TA1 and TC2.

In steps c-1) and c-2) the Terminal shall work with the UICC simulator.

In step c-3) the Terminal shall initiate a deactivation of the UICC within 960 etu following the excess of WWT.

7.2.2 Command processing, ACK, NACK, NULL procedure bytes

7.2.2.1 Definition and applicability

Procedure bytes are used to keep up the communication between the terminal and the UICC. They shall not be transmitted to the Application Layer.

The status bytes SW1 SW2 form an end sequence indicating the status of the UICC at the end of a command.

For applicability of this test case see clause 3.8.

7.2.2.2 Conformance requirement

The Terminal shall correctly use the different modes of data transmission.

7.2.2.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.2.3.

ISO/IEC 7816-3 [2], clause 8.3.

7.2.2.3 Test purpose

To verify that the Terminal correctly uses the different modes of data transmission.

7.2.2.4 Method of test

7.2.2.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

T=0 ATR shall have been received and eventual PPS procedure successfully completed.

7.2.2.4.2 Procedure

- a) The Terminal shall be made to initiate a VERIFY PIN command with 8 bytes of data.
- b) The UICC simulator shall answer the first 5 bytes with ACK=INS complemented.
- c1) The UICC simulator shall answer the next data byte with NULL (NULL="60"). This byte is sent between 0.8 and 1.0 x Work Waiting Time after the previous procedure byte.
- c2) The UICC simulator shall send a second NULL (NULL="60"). This byte is sent between 0.8 and 1.0 x Work Waiting Time after the previous procedure byte.
- c3) The UICC simulator shall send a third NULL (NULL="60"). This byte is sent between 0.8 and 1.0 x Work Waiting Time after the previous procedure byte.
- d) The UICC simulator shall then send ACK=INS. This byte is sent between 0.8 and 1.0 x Work Waiting Time after the previous procedure byte.
- e) The UICC simulator shall answer the transmission of the rest of the data with NULL.
- f) The UICC simulator shall then send SW1 and SW2, indicating correct execution of the command ("90" and "00" for SW1 and SW2 respectively). These bytes are sent when the elapsed time since step d) is greater than the Work Waiting Time.

7.2.2.5 Acceptance criteria

The command shall be executed correctly.

7.2.3 Case 2 command, use of procedure bytes '61xx' and '6Cxx'

7.2.3.1 Definition and applicability

Procedure bytes '61XX' and '6CXX' are returned by the UICC to control exchanges between the Transport Layer of the Terminal and the UICC, and should never be returned to the Application Layer of the Terminal. Command processing in the UICC is not complete if it has returned procedure bytes '61XX' or '6CXX'.

For applicability of this test case see clause 3.8.

7.2.3.2 Conformance requirement

The UICC returns procedure bytes '61xx 'and '6Cxx' to the Transport Layer of the Terminal to indicate to it the manner in which it should retrieve the data requested by the command currently being processed. These procedure bytes are only used when processing case 2 and 4 commands using T=0.

7.2.3.2.1 Reference

ETSI TS 102 221 [1], clause 7.3.1.1.5.

ISO/IEC 7816-3 [2], clause 8.3.

7.2.3.3 Test purpose

To verify that the Terminal correctly handles the procedure bytes '61XX' and '6CXX' when processing a case 2 command.

7.2.3.4 Method of test

7.2.3.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

T=0 ATR shall have been received and eventual PPS procedure successfully completed.

7.2.3.4.2 Procedure

- a) The Terminal shall be made to initiate a case 2 command with Le > Luicc (ex: READ RECORD command).
- b) The UICC simulator shall send '6CLuicc' procedure bytes.
- c) Following receipt of the command, the UICC simulator shall send '61xx' procedure bytes.
- d) Following receipt of the command, the UICC simulator shall send corresponding data + '61yy' procedure bytes.
- e) Following receipt of the command, the UICC simulator shall then send the rest of the data and SW1 and SW2, indicating correct execution of the command ("90" and "00" for SW1 and SW2 respectively).

7.2.3.5 Acceptance criteria

After step b) the Terminal shall send the previous command with Le = 'Luicc'.

After step c) the Terminal shall send a GET RESPONSE command with Le = 'xx'.

After step f) the Terminal shall send a GET RESPONSE command with Le = 'yy'.

7.2.4 Case 4 command, use of procedure bytes '61xx'

7.2.4.1 Definition and applicability

Procedure bytes '61XX' and '6CXX' are returned by the UICC to control exchanges between the Transport Layer of the Terminal and the UICC, and should never be returned to the Application Layer of the Terminal. Command processing in the UICC is not complete if it has returned procedure bytes '61XX' or '6CXX'.

For applicability of this test case see clause 3.8.

7.2.4.2 Conformance requirement

The UICC returns procedure bytes '61xx' and '6Cxx' to the Transport Layer of the Terminal to indicate to it the manner in which it should retrieve the data requested by the command currently being processed. These procedure bytes are only used when processing case 2 and 4 commands using T=0.

7.2.4.2.1 Reference

ETSI TS 102 221 [1], clause 7.3.1.1.5.

ISO/IEC 7816-3 [2], clause 8.3.

7.2.4.3 Test purpose

To verify that the Terminal correctly handles the procedure bytes '61XX' when processing a case 4 command.

7.2.4.4 Method of test

7.2.4.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

T=0 ATR shall have been received and eventual PPS procedure successfully completed.

7.2.4.4.2 Procedure

- a) The Terminal shall be made to initiate a case 4 command with Le > Luicc (ex: SELECT command).
- b) The UICC simulator shall answer the command header with INS and send '61xx' procedure bytes following reception of data.
- c) Following receipt of the command, the UICC simulator shall send corresponding data + '61yy' procedure bytes.
- d) Following receipt of the command, the UICC simulator shall then send the rest of the data and SW1 and SW2, indicating correct execution of the command ("90" and "00" for SW1 and SW2 respectively).

7.2.4.5 Acceptance criteria

After step b) the Terminal shall send a GET RESPONSE command with Le = 'xx'.

After step c) the Terminal shall send a GET RESPONSE command with Le = 'yy'.

7.2.5 Command processing, warning and error status bytes

7.2.5.1 Definition and applicability

The status bytes SW1 SW2 form an end sequence indicating the status of the UICC at the end of a command.

For applicability of this test case see clause 3.8.

7.2.5.2 Conformance requirement

In the case of an error, the UICC may return status indicating error or warning conditions instead of the '61xx' or '6Cxx' response.

63

7.2.5.2.1 Reference

ETSI TS 102 221 [1], clauses 7.2.2.3 and 10.2.1.

7.2.5.3 Test purpose

To verify that the Terminal correctly handles status bytes different than '9000'.

7.2.5.4 Method of test

7.2.5.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

T=0 ATR shall have been received and eventual PPS procedure successfully completed.

7.2.5.4.2 Procedure

- a) Warning:
 - a-1) The Terminal shall be made to initiate a case 4 command (ex: SELECT command).
 - a-2) The UICC simulator shall send warning status bytes ('62xx' '63xx' or '9xxx').
 - a-3) Following receipt of the command, the UICC simulator shall then send the rest of the data and SW1 and SW2, indicating correct execution of the command ("90" and "00" for SW1 and SW2 respectively).
- b) Error:
 - b-1) The Terminal shall be made to initiate a case 4 command (ex: SELECT command).
 - b-2) The UICC simulator shall send error status bytes ('6xxx' except '6Cxx', '61xx', '62xx' and '63xx').

7.2.5.5 Acceptance criteria

After step a-2) the Terminal shall send a GET RESPONSE command with Le = '00'.

After step b-2) the Terminal shall discontinue processing of the command.

7.2.6 Error correction

7.2.6.1 Definition and applicability

If the UICC as receiver detects a parity error within 11 etu \pm 0,2 etu starting from the leading edge of the start bit, in a character just received, it shall set I/O to state L to indicate the error to the Terminal.

For applicability of this test case see clause 3.8.

7.2.6.2 Conformance requirement

The error detection and correction procedure is mandatory for T=0 protocol except for the Terminal during the ATR-procedure.

7.2.6.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.2.4.

7.2.6.3 Test purpose

To verify the error handling during the transmission from the Terminal to the UICC.

7.2.6.4 Method of test

7.2.6.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

7.2.6.4.2 Procedure

The UICC simulator shall transmit an error signal in response to a received character by setting the I/O line to state L for a maximum of 2 etu and a minimum of 1 etu, 10,5 etu \pm 0,2 etu after the leading edge of the start bit of the received character.

7.2.6.5 Acceptance criteria

The Terminal shall repeat the disputed character after a minimum delay of 2 etu.

7.2.7 Error detection

7.2.7.1 Definition and applicability

If the Terminal as receiver detects a parity error within 11 ± 0.2 etu starting from the leading edge of the start bit, in a character just received, it shall set I/O to state L to indicate the error to the UICC.

For applicability of this test case see clause 3.8.

7.2.7.2 Conformance requirement

The error detection and correction procedure is mandatory for T=0 protocol except for the Terminal during the ATR-procedure.

7.2.7.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.2.4.

7.2.7.3 Test purpose

To verify the error handling during the transmission from the UICC to the Terminal.

7.2.7.4 Method of test

7.2.7.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

7.2.7.4.2 Procedure

The UICC simulator shall send a response with a parity error and check that the terminals correctly handles it.

7.2.7.5 Acceptance criteria

The Terminal shall detect the parity error by setting the I/O line to state L for a maximum of 2 etu and a minimum of 1 etu, 10,5 etu \pm 0,2 etu after the leading edge of the start bit of the erroneous character and correctly evaluate the character when repeated by the UICC simulator.

7.3 T=1 protocol

7.3.1 Character Waiting Time

7.3.1.1 Definition and applicability

CWT is defined as the maximum delay between the leading edges of two consecutive characters in the block.

For applicability of this test case see clause 3.8.

7.3.1.2 Conformance requirement

CWI is used to calculate CWT and shall be in the range from 0 to 5. The value is set in bits b4 to b1 in TB3. The value of CWT may be calculated from the following equation: $CWT = (11 + 2^{CWI})$ etu.

7.3.1.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.3.1.

ISO/IEC 7816-3 [2], clause 9.5.3.

7.3.1.3 Test purpose

To verify that the Terminal respects the CWT indicated by the UICC.

7.3.1.4 Method of test

7.3.1.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

7.3.1.4.2 Procedure

a) Upon reception of a reset the UICC simulator shall transmit the ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct convention
T0	'97'	TA1, and TD1 are present
		7 bytes of historical bytes
TA1	'11'	Clock rate conversion factor FI=1 (F=372)
		Baud rate adjustment factor DI=1 (D=1)
TD1	'81'	Only TD2 is present
		Protocol T=1 supported by UICC
TD2	'A1'	TB3 and TD3 are present
		Protocol T=1 supported by UICC
TB3	'05'	Block Waiting Integer=0
		Character Waiting Integer=5 indicating CWT=43 etu
TD3	'1F'	Only TA4 is present
		Global interface bytes following (T=15)
TA4	'46'	Clock stop supported (low electrical state)
		1,8 V technology UICC
T1	'80'	
T2	'31'	Card data services
T3	'A0'	SELECT by AID supported
		EFDIR present
T4	'73'	Card capabilities
T5	'BE'	SFI supported
T6	'21'	Data Coding Byte
T7	'00'	No extended Lc and Le
		No Logical channels supported
TCK	'07'	Check byte

- b) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring reception of an I-Block.
 - b-1) The UICC simulator shall send the I-Block (data + '9000' indicating correct execution of the command) using CWT=11 etu.
 - b-2) The UICC simulator shall send the I-Block (data + '9000' indicating correct execution of the command) using CWT=43 etu.

7.3.1.5 Acceptance criteria

In step b.1) and b.2) the Terminal shall acknowledge the error free I-Block.

7.3.2 Block Timing

7.3.2.1 Definition and applicability

BWT is defined as the maximum delay between the leading edge of the last character of the block received by the card and the leading edge of the first character of the next block sent by the card.

BGT is defined as the minimum delay between the leading edge of two consecutive characters sent in opposite directions. The value of BGT shall be 22 etu.

For applicability of this test case see clause 3.8.

7.3.2.2 Conformance requirement

BWI is used to calculate BWT and shall be in the range from 0 to 4. The value is set in bits b5 to b8 in TB3. The value of BWT may be calculated from the following equation: $BWT = 11 + (2^{BWI} \times 960 \times 372/f)$ etu.

The delay between the last character of a block received by the UICC and the first character of the next block sent from the UICC shall be in the interval: BGT < delay < BWT.

7.3.2.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.3.

ISO/IEC 7816-3 [2], clause 9.5.3.

7.3.2.3 Test purpose

To verify that the Terminal respects the BGT and BWT indicated by the UICC in the ATR and detects time-out.

7.3.2.4 Method of test

7.3.2.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

7.3.2.4.2 Procedure

a) Upon reception of a reset the UICC simulator shall transmit the ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct convention
T0	'97'	TA1, and TD1 are present
		7 bytes of historical bytes
TA1	'11'	Clock rate conversion factor FI=1 (F=372)
		Baud rate adjustment factor DI=1 (D=1)
TD1	'81'	Only TD2 is present
		Protocol T=1 supported by UICC
TD2	'A1'	TB3 and TD3 are present
		Protocol T=1 supported by UICC
TB3	'31'	Block Waiting Integer=3 indicating
		BWT = 11 + (8 × 960 × 372 / f) etu
		Character Waiting Integer=1 indicating CWT=13 etu
TD3	'1F'	Only TA4 is present
		Global interface bytes following
TA4	'46'	Clock stop supported (low electrical state)
		1,8 V technology UICC
T1	'80'	
T2	'31'	Card data services
Т3	'A0'	SELECT by AID supported
		EFDIR present
T4	'73'	Card capabilities
T5	'BE'	SFI supported
T6	'21'	Data Coding Byte

Character	Value	Description
T7	'00'	No extended Lc and Le
		No Logical channels supported
TCK	'33'	Check byte

- b) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring reception of chained I-Blocks.
- c) The UICC simulator shall measure the delay between the last character of each block sent by the UICC and the first character of each following block sent by the Terminal.

d) BWT:

- d-1) The UICC simulator shall send the I-Blocks using BGT = 22 etu.
- d-2) The UICC simulator shall send each I-Block using BWT = $11 + (2^{BWI} \times 960 \times 372/f)$ etu.

BWT excess:

d-3) The UICC simulator shall not send an I-Block.

7.3.2.5 Acceptance criteria

In step c) the Terminal shall use a BGT of at least 22 etus.

In steps d-1) and d-2) the Terminal shall acknowledge reception of the I-Blocks without error.

In step d-3) the Terminal shall detect a time-out and send an R-Block requesting retransmission of the last block.

7.3.3 Block Waiting Time extension

7.3.3.1 Definition and applicability

WTX is a parameter used to ask for more time to process a command.

Supervisory blocks, S-block, are used to send control information.

S-blocks are always used in pairs. A S(request) is always followed by a S(response) block.

- S(WTX request), a request for an extension of the waiting time;
- S(WTX response), an acknowledge of the extension of the waiting time.

For applicability of this test case see clause 3.8.

7.3.3.2 Conformance requirement

The UICC might need more than BWT to process the previously received block, a S(WTX request) is sent by the UICC. The terminal shall acknowledge with a S(WTX response).

When an S(... request) has been sent and either a BWT time-out occurs (with the terminal) or the received response is not a S(... response), the S(... request) shall be resent.

7.3.3.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.3.1.

ISO/IEC 7816-3 [2], clauses 9.5.3 and 9.7.3, scenarios 2, 14 and 15.

7.3.3.3 Test purpose

- 1) To verify that the Terminal respects the WTX procedure and applies the extended BWT.
- 2) To verify that the Terminal handles the different types of errors in S(... request).

7.3.3.4 Method of test

7.3.3.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

7.3.3.4.2 Procedure

a) Upon reception of a reset the UICC simulator shall transmit the ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct convention
Т0	'97'	TA1, and TD1 are present
		7 bytes of historical bytes
TA1	'11'	Clock rate conversion factor FI=1 (F=372)
		Baud rate adjustment factor DI=1 (D=1)
TD1	'81'	Only TD2 is present
		Protocol T=1 supported by UICC
TD2	'A1'	TB3 and TD3 are present
		Protocol T=1 supported by UICC
TB3	'21'	Block Waiting Integer=2 indicating
		$BWT = 11 + (4 \times 960 \times 372/f)$ etu
		Character Waiting Integer=1 indicating CWT=13 etu
TD3	'1F'	Only TA4 is present
		Global interface bytes following
TA4	'46'	Clock stop supported (low electrical state)
		1,8 V technology UICC
T1	'80'	
T2	'31'	Card data services
T3	'A0'	SELECT by AID supported
		EFDIR present
T4	'73'	Card capabilities
T5	'BE'	SFI supported
T6	'21'	Data Coding Byte
T7	'00'	No extended Lc and Le
		No Logical channels supported
TCK	'23'	Check byte

- b) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring exchange of I-Blocks.
- c-1) Error free S(WTX request):
 - c-1-1) Following receipt of the I-block, the UICC simulator shall send a S(WTX request) without error (BWT multiplied by 2).
 - c-1-2) The UICC simulator shall use the extended BWT when receiving the S(WTX response), then complete the command (data + '9000' indicating correct execution of the command).
- c-2) Error in S(WTX request):
 - c-2-1) Following receipt of the I-block, the UICC simulator shall send a S(WTX request) and generate the following errors:
 - Parity error.
 - NAD ≠ '00'.
 - S(WTX response) instead of S(WTX request).
 - Other S(.... response) instead of S(WTX request).
 - LEN error.

- c-2-2) Following reception of the block sent by the Terminal (correct or with error assumed) the UICC simulator shall retransmit the S(WTX request) without error.
- c-2-3) The UICC simulator shall use the extended BWT when receiving the S(WTX response), then complete the command (data + '9000' indicating correct execution of the command).

7.3.3.5 Acceptance criteria

After steps c-1-1) and c-2-2) the Terminal shall send a S(WTX response).

After step c-2-1) the Terminal shall send an R-Block requesting retransmission of the last block.

7.3.4 Chaining - Respect of IFSC by Terminal

7.3.4.1 Definition and applicability

Chaining allows the terminal or the UICC to transfer information, which is longer than IFSC or IFSD. If information longer than IFSC or IFSD is transferred, the information should be divided into pieces, each has a length \leq IFSC or IFSD. Each piece should be sent in an I-block using the chaining function.

The IFSC defines the maximum length of the information field of blocks that can be received by the UICC.

For applicability of this test case see clause 3.8.

7.3.4.2 Conformance requirement

The default value of the IFSC is 32 bytes. Another value may be indicated in TA3 of the ATR.

When the terminal is the sender, all I-blocks of a chain shall have LEN = IFSC bytes except for the last, which could have a value in the range of 0 to IFSC.

When a receiver receives a more-data I-block, a R(N(R)) shall be sent. N(R) = N(S) of the expected I-block. At least one chained block should follow.

7.3.4.2.1 Reference

ETSI TS 102 221 [1], clauses 7.2.3.1.1 and 7.2.3.5.

ISO/IEC 7816-3 [2], clause 9.7.3, scenarios 5 and 6.

7.3.4.3 Test purpose

To verify that the Terminal respects the Information Field Size of the UICC in chaining mode.

7.3.4.4 Method of test

7.3.4.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

7.3.4.4.2 Procedure

a) No TA3.

a-1) Upon reception of a reset the UICC simulator shall transmit the ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct convention
Т0	'97'	TA1, and TD1 are present
		7 bytes of historical bytes
TA1	'11'	Clock rate conversion factor FI=1 (F=372)
		Baud rate adjustment factor DI=1 (D=1)
TD1	'81'	Only TD2 is present
		Protocol T=1 supported by UICC
TD2	'A1'	TB3 and TD3 are present
		Protocol T=1 supported by UICC

Character	Value	Description
TB3	'00'	Block Waiting Integer=0
		Character Waiting Integer=0
TD3	'1F'	Only TA4 is present
		Global interface bytes following
TA4	'46'	Clock stop supported (low electrical state)
		1,8 V technology UICC
T1	'80'	
T2	'31'	Card data services
Т3	'A0'	SELECT by AID supported
		EFDIR present
T4	'73'	Card capabilities
T5	'BE'	SFI supported
T6	'21'	Data Coding Byte
Τ7	'00'	No extended Lc and Le
		No Logical channels supported
TCK	'02'	Check byte

- a-2) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring sending of chained I-Blocks.
- a-3) Following receipt of the command, the UICC simulator shall evaluate the length and acknowledge reception of the received I-Blocks without error.

b) TA3='FE'

b-1) Upon reception of a reset the UICC simulator shall transmit the ATR as follows:

Character	Value	Description
TS	'3B'	Indicates direct convention
T0	'97'	TA1, and TD1 are present
		7 bytes of historical bytes
TA1	'11'	Clock rate conversion factor FI=1 (F=372)
		Baud rate adjustment factor DI=1 (D=1)
TD1	'81'	Only TD2 is present
		Protocol T=1 supported by UICC
TD2	'B1'	TA3, TB3 and TD3 are present
		Protocol T=1 supported by UICC
TA3	'FE'	IFSC is 254 bytes long
TB3	'00'	Block Waiting Integer=0
		Character Waiting Integer=0
TD3	'1F'	Only TA4 is present
		Global interface bytes following
TA4	'46'	Clock stop supported (low electrical state)
		1,8 V technology UICC
T1	'80'	
T2	'31'	Card data services
T3	'A0'	SELECT by AID supported
		EFDIR present
T4	'73'	Card capabilities
T5	'BE'	SFI supported
T6	'21'	Data Coding Byte
T7	'00'	No extended Lc and Le
		No Logical channels supported
TCK	'EC'	Check byte

- b-2) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring sending of chained I-Blocks.
- b-3) Following receipt of the command, the UICC simulator shall evaluate the length and acknowledge reception of the received I-Blocks without error.

7.3.4.5 Acceptance criteria

In step a-2) the Terminal shall send the chained I-Blocks, except the last one, using the default value of IFSC, i.e. 32 bytes long information field.

In step b-2) the Terminal shall send the chained I-Blocks, except the last one, using the specified value of IFSC, i.e. 254 bytes long information field.

7.3.5 Chaining - IFSD management

7.3.5.1 Definition and applicability

Chaining allows the Terminal or the UICC to transfer information, which is longer than IFSC or IFSD. If information longer than IFSC or IFSD is transferred, the information should be divided into pieces, each has a length \leq IFSC or IFSD. Each piece should be sent in an I-block using the chaining function.

When a receiver receives a more-data I-block, a R(N(R)) shall be sent. N(R) = N(S) of the expected I-block. At least one chained block should follow.

The IFSD defines the maximum length of the information field of blocks that the terminal can receive.

The default value of the IFSD is 32 bytes and may be adjusted during the card session. The maximum value of the IFSD is 254 bytes.

For applicability of this test case see clause 3.8.

7.3.5.2 Conformance requirement

When the UICC is the sender, all I-blocks of a chain shall have LEN \leq IFSD bytes per block.

7.3.5.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.3.

7.3.5.3 Test purpose

To verify that the Terminal correctly handles the Information Field Size in chaining mode.

7.3.5.4 Method of test

7.3.5.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

ATR shall have been received and eventual PPS procedure successfully completed.

7.3.5.4.2 Procedure

- a) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring reception of chained I-Blocks.
- b) The UICC simulator shall send an I-Block with LEN > IFSD.
- c) Following correct receipt of the next block the UICC simulator shall send the rest of I-Blocks (data + '9000' indicating correct execution of the command).

7.3.5.5 Acceptance criteria

In step b), the Terminal shall detect the incorrect LEN and send an R-Block requesting retransmission of the last block.

In step c) the Terminal shall acknowledge reception of the I-Blocks without error by sending R-Blocks with N(R)=sequence number of expected I-Block.

7.3.6 I-Block error correction

7.3.6.1 Definition and applicability

Information blocks are used to transfer command and response APDUs.

The I-blocks are denoted as follows: I(N(S), M) where:

- N(S) is the send-sequence number of the block;
- M is the more-data bit used in the chaining function.

For applicability of this test case see clause 3.8.

7.3.6.2 Conformance requirement

When an I-block has been sent and a BWT time-out occurs or an invalid block has been received (with the terminal), an R-block is sent, which requests with its N(R) for the expected I-block with N(S)=N(R).

7.3.6.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.3.4.

ISO/IEC 7816-3 [2], clause 9.7.3, scenario 8.

7.3.6.3 Test purpose

To verify that the Terminal sends an I-Block again when notified incorrect reception by the UICC (R-Block meaning error).

7.3.6.4 Method of test

7.3.6.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

ATR shall have been received and eventual PPS procedure successfully completed.

7.3.6.4.2 Procedure

- a) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring sending of chained I-Blocks.
- b) The UICC simulator shall assume each transmitted I-Block, including the last non-chained one, is invalid by sending an R-Block requesting retransmission.

7.3.6.5 Acceptance criteria

In step b), the Terminal shall resend each disputed I-Block.

7.3.7 I-Block error detection

7.3.7.1 Definition and applicability

Information blocks are used to transfer command and response APDUs.

The I-blocks are denoted as follows: I(N(S), M) where:

- N(S) is the send-sequence number of the block;
- M is the more-data bit used in the chaining function.

For applicability of this test case see clause 3.8.
7.3.7.2 Conformance requirement

When an I-block has been sent and a BWT time-out occurs or an invalid block has been received (with the terminal), an R-block is sent, which requests with its N(R) for the expected I-block with N(S)=N(R).

7.3.7.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.3.4.

ISO/IEC 7816-3 [2], clause 9.7.3, scenario 9.

7.3.7.3 Test purpose

To verify that the Terminal correctly handles the different types of invalid I-Blocks.

7.3.7.4 Method of test

7.3.7.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

ATR shall have been received and eventual PPS procedure successfully completed.

7.3.7.4.2 Procedure

- a) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring reception of I-Blocks.
- b) The UICC simulator shall send I-Blocks and generate the following errors:
 - Parity error.
 - NAD \neq '00'.
 - PCB with wrong sequence number.
 - PCB of an R-Block.
 - PCB of an S-Block.
 - LEN error (= 'FF').
 - EDC error.
- c) Following correct reception of the block sent by the Terminal, the UICC simulator shall retransmit the I-Block without error and complete the command (data + '9000' indicating correct execution of the command).
- NOTE: Test can be achieved either by generating the errors in one session using chained blocks or through separate tests generating one error.

7.3.7.5 Acceptance criteria

In step b), the Terminal shall detect the invalid block and send an R-Block requesting retransmission of the last block (N(R)=sequence number of last I-Block).

In step c) the Terminal shall acknowledge reception of the I-Block without error.

7.3.8 R-Block error handling in non-chaining mode

7.3.8.1 Definition and applicability

Receive-ready blocks, R-blocks, are used to transfer acknowledgements.

The R-blocks are denoted as follows: R(N(R)), where:

- N(R) is the number of the expected I-block.

For applicability of this test case see clause 3.8.

7.3.8.2 Conformance requirement

When an R-block was sent and an invalid block is received or BWT time-out, the R-block will be resent.

7.3.8.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.3.4.

ISO/IEC 7816-3 [2], clause 9.7.3, scenario 10.

7.3.8.3 Test purpose

To verify that the Terminal handles the different types of invalid R-Blocks and correctly recovers while sending non chained data.

7.3.8.4 Method of test

7.3.8.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

ATR shall have been received and eventual PPS procedure successfully completed.

7.3.8.4.2 Procedure

- a) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring sending of a non chained I-Block.
- b) The UICC simulator shall assume the received block is invalid by sending an R-Block and generate the following errors:
 - Parity error.
 - NAD ≠ '00'.
 - PCB with wrong sequence number.
 - PCB with b6=1.
 - PCB of an S-Block.
 - LEN error.
 - EDC error.
- c) Following correct reception of the block sent by the Terminal, the UICC simulator shall retransmit the R-Block without error.

7.3.8.5 Acceptance criteria

In step b) the Terminal shall detect the invalid block and send an R-Block requesting retransmission of the last block (N(R)=sequence number of invalid R-Block).

After step c), the Terminal shall resend the first I-Block.

7.3.9 R-Block error handling in chaining mode

7.3.9.1 Definition and applicability

Receive-ready blocks, R-blocks, are used to transfer acknowledgements.

The R-blocks are denoted as follows: R(N(R)), where:

- N(R) is the number of the expected I-block.

For applicability of this test case see clause 3.8.

7.3.9.2 Conformance requirement

When an R-block was sent and an invalid block is received or BWT time-out, the R-block will be resent.

7.3.9.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.3.4.

ISO/IEC 7816-3 [2], clause 9.7.3, scenario 21.

7.3.9.3 Test purpose

To verify that the Terminal handles the different types of invalid R-Blocks and correctly recovers while sending chained data.

7.3.9.4 Method of test

7.3.9.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

ATR shall have been received and eventual PPS procedure successfully completed.

7.3.9.4.2 Procedure

- a) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring sending of chained I-Blocks.
- b) The UICC simulator shall send an invalid R-Block and generate the following errors:
 - Parity error.
 - NAD \neq '00'.
 - PCB with b6=1.
 - PCB of an S-Block.
 - LEN error.
 - EDC error.
- c) Following correct reception of the block sent by the Terminal, the UICC simulator shall retransmit the R-Block without error.

7.3.9.5 Acceptance criteria

In step b) the Terminal shall detect the invalid block and send an R-Block requesting retransmission of the last block (N(R)=sequence number of invalid R-Block).

After step c), the Terminal shall send the rest of chained data (I-Block).

7.3.10 Successive errors in both directions

7.3.10.1 Definition and applicability

Receive-ready blocks, R-blocks, are used to transfer acknowledgements.

The R-blocks are denoted as follows: R(N(R)), where:

• N(R) is the number of the expected I-block.

For applicability of this test case see clause 3.8.

7.3.10.2 Conformance requirement

When an R-block was sent and an invalid block is received or BWT time-out, the R-block will be resent.

7.3.10.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.3.4.

ISO/IEC 7816-3 [2], clause 9.7.3, scenarios 12 and 13.

7.3.10.3 Test purpose

To verify that the Terminal properly recovers after receiving and being notified errors successively.

7.3.10.4 Method of test

7.3.10.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

ATR shall have been received and eventual PPS procedure successfully completed.

7.3.10.4.2 Procedure

- a) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring reception of I-Blocks.
- b) The UICC simulator shall send an invalid I-Block.
- c) Following correct reception of the block sent by the Terminal, the UICC simulator shall assume the received block is invalid by sending an R-Block, also invalid.
- d) Following correct reception of the block sent by the Terminal:
 - d-1) No error:
 - d-1-1) The UICC simulator shall retransmit the I-Block without error and complete the command (data + '9000' indicating correct execution of the command).
 - d-2) Error assumed:
 - d-2-1) The UICC simulator shall assume the received block is invalid by sending an R-Block requesting retransmission (N(R)= correct sequence number of step c)).
 - d-2-2) Following correct reception of the block sent by the Terminal, the UICC simulator shall complete the command (data + '9000' indicating correct execution of the command).

7.3.10.5 Acceptance criteria

After step b) and c), the Terminal shall detect the invalid block and send an R-Block requesting retransmission of the last block (N(R)=sequence number of invalid I-Block).

After step d-2-1), the Terminal shall resend the previous R-Block with N(R)=sequence number of invalid I-Block.

After step d-1) and d-2-2), the Terminal shall acknowledge the error free I-Block(s).

7.3.11 Chaining - Abortion

7.3.11.1 Definition and applicability

Supervisory blocks, S-block, are used to send control information.

S-blocks are always used in pairs. A S(request) is always followed by a S(response) block.

- S(ABORT request), a request to abort the chain function;
- S(ABORT response), an acknowledge of the abortion of the chain function.

For applicability of this test case see clause 3.8.

7.3.11.2 Conformance requirement

When an S(... request) has been sent and either a BWT time-out occurs (with the terminal) or the received response is not a S(... response), the S(... request) shall be resent. But if an S(... response) has been sent and either an invalid block is received or a BWT time-out occurs (with the terminal), an R-block shall be sent.

7.3.11.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.3.4.

ISO/IEC 7816-3 [2], clause 9.7.3, scenarios 26 and 27.

7.3.11.3 Test purpose

To verify that the Terminal correctly handles the abortion procedure in chaining mode.

7.3.11.4 Method of test

7.3.11.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

ATR shall have been received and eventual PPS procedure successfully completed.

7.3.11.4.2 Procedure

- a) Terminal sends chained data:
 - a-1) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring sending of chained I-Blocks.
 - a-2) The UICC simulator shall acknowledge receipt of the first chained I-Block by sending an R-Block without error.
 - a-3) Following receipt of the second I-Block, the UICC simulator shall send an S(ABORT request).
 - a-4) The UICC simulator shall acknowledge receipt of the response and give back the Terminal the right to send (R-Block without error) and complete the next command.
- b) UICC sends chained data:
 - b-1) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring reception of chained I-Blocks.
 - b-2) The UICC simulator shall transmit the first chained I-Block without error.
 - b-3) Following correct reception of the block sent by the Terminal, the UICC simulator shall send an S(ABORT request).
 - b-4) The UICC simulator shall acknowledge receipt of the response without error.

b-5) The UICC simulator shall restart and complete the command (data + '9000' indicating correct execution of the command).

7.3.11.5 Acceptance criteria

After steps a-3) and b-3), the Terminal shall send an S(ABORT response).

In step b-5) the Terminal shall acknowledge reception of the I-Blocks without error by sending R-Blocks with N(R)=sequence number of expected I-Block.

7.3.12 Block repetition and resynchronization

7.3.12.1 Definition and applicability

Resynchronization of the protocol may be attempted at three consecutive levels. If one level is unsuccessful, then the next level is tried.

- For the terminal, the three levels are:
 - Retransmission of blocks.
 - Use of S(RESYNCH request).
 - Card reset or deactivation.

Supervisory blocks, S-block, are used to send control information.

S-blocks are always used in pairs. A S(request) is always followed by a S(response) block.

- S(RESYNCH request), a request of a resynchronization;
- S(RESYNCH response), an acknowledge of the resynchronization.

For applicability of this test case see clause 3.8.

7.3.12.2 Conformance requirement

When an S(... request) has been sent and either a BWT time-out occurs (with the terminal) or the received response is not a S(... response), the S(... request) shall be resent. But if an S(... response) has been sent and either an invalid block is received or a BWT time-out occurs (with the terminal), an R-block shall be sent.

If the terminal fails to receive an error-free block during a card-session, a maximum of two further attempts is allowed before a S(RESYNCH request) is sent.

7.3.12.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.3.4.

ISO/IEC 7816-3 [2], clause 9.7.3, scenarios 29, 30, 31, 32 and 34.

7.3.12.3 Test purpose

- 1) To verify that the Terminal resynchronizes the UICC if block repetition is unsuccessful.
- 2) To verify that the Terminal correctly handles an invalid response to an S(... request).

7.3.12.4 Method of test

7.3.12.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

ATR shall have been received and eventual PPS procedure successfully completed.

7.3.12.4.2 Procedure

- a) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring sending of an I-Block.
- b) Following receipt of the first I-Block, the UICC simulator shall send an erroneous block or be unresponsive.
- c) Following correct reception of the block sent by the Terminal, the UICC simulator shall send two more erroneous blocks or remain unresponsive two more times.
 - d-1) No error:
 - d-1-1) Following correct reception of the block (S(RESYNCH request)) sent by the Terminal, the UICC simulator shall send a S(RESYNCH response), then complete the next command without error.
 - d-2) Error assumed:
 - d-2-1) Following correct reception of the block (S(RESYNCH request)) sent by the Terminal, the UICC simulator shall send a S(RESYNCH response) and generate the following errors:
 - Parity error.
 - NAD ≠ '00'.
 - LEN error (≠ '01').
 - S(RESYNCH request) instead of S(RESYNCH response).
 - Other S(... response).
 - EDC error.
 - d-2-2) Following correct reception of the block (S(RESYNCH request)) sent by the Terminal, the UICC simulator shall send a S(RESYNCH response), then complete the next command without error.

7.3.12.5 Acceptance criteria

After step b), the Terminal shall send an R-Block requesting retransmission.

In step c), the Terminal shall send the same R-Block as in b) two more times, then initiate an S(RESYNCH request).

After step d-2-1), the Terminal shall resend an S(RESYNCH request).

7.3.13 UICC is unresponsive

7.3.13.1 Definition and applicability

Resynchronization of the protocol may be attempted at three consecutive levels. If one level is unsuccessful, then the next level is tried.

- For the terminal, the three levels are:
 - Retransmission of blocks.
 - Use of S(RESYNCH request).
 - Card reset or deactivation.

For applicability of this test case see clause 3.8.

7.3.13.2 Conformance requirement

After an ATR due to a Warm reset or successful PPS procedure, the communication between the terminal and the UICC can be initiated. But if the terminal fails to receive an error-free block, in the beginning of the protocol, a maximum of two more successive attempts to receive the block is allowed before resetting or a deactivation of the card takes place.

If the terminal fails to receive an error-free block during a card-session, a maximum of two further attempts is allowed before a S(RESYNCH request) is sent.

7.3.13.2.1 Reference

ETSI TS 102 221 [1], clause 7.2.3.4.

ISO/IEC 7816-3 [2], clause 9.7.3, scenarios 33 and 35.

7.3.13.3 Test purpose

To verify that the Terminal correctly resets or deactivates the UICC at the start of the protocol and during the protocol if resynchronization is unsuccessful.

7.3.13.4 Method of test

7.3.13.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator, and powered on.

ATR shall have been received and eventual PPS procedure successfully completed.

7.3.13.4.2 Procedure

- a) At the start of the protocol:
 - a-1) Following receipt of the first block, the UICC simulator shall be unresponsive.
 - a-2) Following correct reception of the block sent by the Terminal, the UICC simulator shall remain unresponsive two more times.
- b) During the protocol:
 - b-1) Following receipt of the first block by the UICC simulator, the Terminal shall be made to initiate a command requiring sending of an I-Block.
 - b-2) Following receipt of the first I-Block, the UICC simulator shall be unresponsive.
 - b-3) Following correct reception of the block sent by the Terminal, the UICC simulator shall remain unresponsive two more times.
 - b-4) Following correct reception of the block (S(RESYNCH request)) sent by the Terminal, the UICC simulator shall remain unresponsive three more times.

7.3.13.5 Acceptance criteria

After step a-1), the Terminal shall:

- send an R-Block if the first block it sent was an I-Block.
- repeat the S-Block if the first block it sent was an S-Block.

In step a-2), the Terminal shall send the same block as in a-1) two more times, then reset or deactivate the UICC.

After step b-2), the Terminal shall send an R-Block with N(R)=sequence number of previous I-Block.

In step b-3), the Terminal shall send the same R-Block as in b-2) two more times, then initiate an S(RESYNCH request).

In step b-4), the Terminal shall resend S(RESYNCH request) two more times, then reset or deactivate the UICC.

8 Application dependent procedures

8.1 UICC presence detection

8.1.1 Definition and applicability

To ensure that the UICC has not been removed during a card session, the Terminal sends, at frequent intervals, a STATUS command during each call.

This procedure shall be used in addition to a mechanical or other device used to detect the removal of a UICC.

8.1.2 Conformance requirement

A STATUS command shall be issued within all 30 second periods of inactivity on the UICC-Terminal interface during a call. Inactivity in this case is defined as starting at the end of the last communication or the last issued STATUS command. If no response data is received to this STATUS command, then the call shall be terminated as soon as possible but at least within 5 s after the STATUS command has been sent. If the DF indicated in response to a STATUS command, then the call shall be terminated as soon as possible but at least within 5 s on as possible but at least within 5 s on as possible but at least within 5 seconds after the response data has been received.

8.1.2.1 Reference

ETSI TS 102 221 [1], clause 14.5.2.

8.1.3 Test purpose

To verify that:

- 1) There are no periods of inactivity on the UICC-Terminal interface greater than 30 seconds during a call.
- 2) The Terminal terminates a call within 5 seconds at the latest after having received an invalid response to the STATUS command.

8.1.4 Method of test

8.1.4.1 Initial conditions

The Terminal shall be connected to the UICC simulator.

All elementary files shall be coded as default.

8.1.4.2 Procedure

- a) A call shall be set up using the generic call setup.
- b) The UICC simulator shall monitor the time of periods of inactivity on the UICC-Terminal interface.
- c) After 3 minutes, the call shall be cleared.
- d) A call shall be set up using the generic call setup.
- e) After one minute after the call was successfully set up, the UICC simulator shall respond to a STATUS command with the response data of the MF.

8.1.5 Acceptance criteria

- 1) During step b), the time of periods of inactivity on the UICC-Terminal interface shall not be longer than 30 s.
- 2) After step e), the Terminal shall terminate the call within 5 seconds at the latest after having received the wrong response to the STATUS command.

Annex A (normative): UICC simulator functional requirement

A.1 General

The UICC simulator shall implement the functions of an UICC as described in ETSI TS 102 221 [1].

A.2 Contacts C1, C3, C7

A.2.1 Default measurement/setting uncertainties

Unless stated otherwise below, the following uncertainties apply:

Voltage measurement uncertainty:	$<\pm50~mV$		
Time measurement uncertainty:	< ±100 ns		

A.2.2 Contact C1

Continuous Spikes:

Voltage measurement uncertainty:	$<\pm100\ mV$				
Current Load Amplitude:	0 mA to 20 mA				
Adjustable Step Size:	1 mA				
Uncertainty:	$< \pm 1 \text{ mA}$				
Additional Current Offset:	0 mA to 5 mA				
Adjustable Step Size:	1 mA				
Uncertainty:	$<\pm 1 \ mA$				
Pulse Width:	100 ns to 500 ns				
Adjustable Step Size:	50 ns				
Uncertainty:	$< \pm 25$ ns				
Rise and Fall Time:	$\leq 50 \text{ ns}$				
Pause Width:	100 ns to 500 ns				
Adjustable Step Size:	50 ns				
Uncertainty:	$< \pm 25$ ns				
Random Spikes:					
Voltage measurement uncertainty: $< \pm 100 \text{ mV}$					
Current Load Amplitude:	50 mA to 200 mA				
Adjustable Step Size:	1 mA				
Uncertainty:	$< \pm 1 \text{ mA}$				

Additional Current Offset:	0 mA to 5 mA
Adjustable Step Size:	1 mA
Uncertainty:	< ±0,1 mA
Pulse Width:	100 ns to 500 ns
Adjustable Step Size:	50 ns
Uncertainty:	< ±25 ns
Rise and Fall Time:	≤ 50 ns
Pause Width:	0,1 ms to 500 ms, randomly varied
Adjustable Step Size:	0,1 ms
Uncertainty:	< ±0,1 ms

A.2.3 Contact C7

The Elementary Time Unit (etu) used in the clauses below refer to the nominal bit duration on the I/O line, as defined in ISO/IEC 7816-3 [2].

Voltage setting uncertainty:	$< \pm 25 \text{ mV}$
Rise and fall Time setting uncertainty:	< ±100 ns
Jitter measurement uncertainty:	$<\pm5\times10\text{E-3}$ etu
Jitter setting uncertainty:	$<\pm5 \times 10$ E-3 etu

A.2.4 Contact C3

Frequency measurement uncertainty:	$<\pm0,5$ %					
Voltage Measurement uncertainty:	$<\pm 50\ mV$					
Rise and fall time measurement uncertainty: $< \pm 5$ ns						
Duty cycle:						
Measurement range:	35 % to 65 %					
Measurement uncertainty:	< ±2,5 %					

A.3 Definition of timing

It shall be possible to define all timings relative to the clock. The UICC simulator shall be able to calculate and to use the absolute values automatically, even if the Terminal changes the frequency during the communication.

Annex B (informative): Change history

The table below indicates all change requests that have been incorporated into the present document since it was created by TC SCP.

Change history								
Date	Meeting	Doc	CR	Rev	Cat		Old	New
2001-06	SCP-06	SCP-010156				TSG-T #11 agreed to transfer the contents of the test specification, 3GPP TS 31.120 to EP SCP. V1.0.0 is submitted to EP SCP for approval. It contains only editorial changes compared to 3GPP TS 31.120 V3.0.0		1.0.0
2001-06	SCP-06	SCP-010194				Undoing a change regarding the coding conventions in clause 3.4	1.0.0	1.0.1
2001-06	SCP-06	-				EP SCP agreed that V1.0.1 was ready to be put under change control. As a result, V3.0.0 was created.	1.0.1	3.0.0
2001-07	SCP-06	SCP-010193 SCP-010200	001		B	Alignment with Rel-4 version of core specification (UICC current consumption values for 3 V and 1.8V) Correction of ATR examples regarding DCB and T4	3.0.0	4.0.0
2002-03	SCP-09	SCP-020052	002		F	Correction of Errors in UICC type recognition	4.0.0	4.1.0
2003-01	SCP-12	SCP-030013 SCP-030062	005		F	Correction of test on processing of ACK, NACK, NULL procedure bytes and correction of CHV Remove UICC as an abbreviation to align with	4.1.0	4.2.0
		3CF-030002	000		U	3GPP TR 21.905		
2003-09	SCP-14	SCP-030288	007		F	Upgrade to Rel-5 version of the specification	4.2.0	5.0.0
2004-05	SCP-17	SCP-040284	010		A	Removal of test 6.4 and modification of the numbering order of electrical tests in clause 5.2	5.0.0	5.1.0
2004-09	SCP#18	SCP-040376	015		A	Removal of transmit for WWT exceeded in test 7.2.1 Timing	5.1.0	5.2.0
2004-11	SCP#19	SCP-040489	020		А	Non-specific Referencing	5.2.0	5.3.0
		SCP-040492	023		Α	Modification of test 7.3.2 Block Timing		
2005-06	SCP#21	SCP-050129	026		F	Correction of test case 7.3.9	5.3.0	5.4.0
		SCP-050131	029		F	Correction of test case 7.3.11		
		SCP-050186	032		F	Correction of references to ISO/IEC 7816		
2005-09	SCP#22	SCP-050297	035		Α	Change of internal references	5.4.0	5.5.0
2006-03	SCP#25	SCP-060160	038		Α	Removal of test case 5.1.5.5	5.5.0	5.6.0
2007-01	SCP#29	SCP-070062	041		A	Essential correction of "Chaining - IFSD management" test case	5.6.0	5.7.0
2007-10	SCP#33	SCP-070446	049		F	CR to ETSI TS 102 230, Rel-5: Adding an applicability table to generate a base for a combined Rel-5 to Rel-7 test specification Note: incorrect CR number renumbered from 42 to 49	5.7.0	5.8.0
2008-07	SCP#38	SCP-080337	047		A	CR 102 230 Rel-5 Essential correction of ATR coding	5.7.0	5.8.0
2008-10	SCP#39	SCP-080414	050		F	Correction of cl. 5.2 chapter numbering	5.8.0	5.9.0
2009-04	SCP#41				-	Upgrade of the specification to Rel-7	5.9.0	7.0.0
2009-04	SCP#41	SCP-090180	053		В	Addition of a test case: analysing rise- and fall-time when a low impedance buffer is selected.	7.0.0	7.1.0
2010-03	SCP#44	SCP(10)0065	055		F	Creation of REL 8 of ETSI TS 102 230	7.1.0	8.0.0
2013-03	SCP#45	SCP(10)0116	059		F	Correction of maximum allowed rise/fall time on contact C7 in test 5.2.5.2	8.0.0	8.1.0
2013-03	SCP#58	SCP(13)000016	061		F	Enhancement of TC 7.2.2 with regards to NULL procedure byte	8.0.0	8.1.0
2013-03	SCP#57	SCP(12)000229	060		F	Creation of ETSI TS 102 230 REL-9	8.1.0	9.0.0
2013-04	SCP#59	SCP(13)000063	062		F	Creation of ETSI TS 102 230 REL-10	9.0.0	10.0.0
2014-02	SCP#62	SCP(14)000009	063		F	Modification of the electrical test cases	10.0.0	10.1.0
2014-04	-	-	-		-	Correction of clause numbering and related release information in applicability table	10.1.0	10.1.1
2014-0	SCP#63	SCP(14)000106r 1	064	1	F	Modification of test case 5.1.5.6	10.1.1	10.2.0

History

Document history					
V10.0.0	July 2013	Publication			
V10.1.0	April 2014	Publication			
V10.1.1	April 2014	Publication			
V10.2.0	March 2015	Publication			

85